

## 150mA Single Inductor - Dual Output Power Supply

### Features

- 2.7V to 5.5V Input Voltage
- Dual Regulated Output Using Single Inductor
- Positive Output Voltage Range:  
4.0V to 6.0V (100mV/Step)
- Negative Output Voltage Range:  
-6.0V to -4.0V (100mV/Step)
- Maximum Output Current: 150mA
- Outstanding Combined Efficiency  
 $\eta > 80\%$  at  $I_{OUT} > 10\text{mA}$   
 $\eta > 85\%$  at  $I_{OUT} > 40\text{mA}$
- Outstanding Transient Response & Line Regulation
- $\pm 1.5\%$  Output Voltage Accuracy
- Shut-Down Supply Current: 1uA
- Under-Voltage Lock-Out and Thermal Shutdown
- WLCSP 1.27mm×2.00mm×0.625mm-15B,  
0.4mm Pitch Package

### General Description

The AW37503 is designed to support positive /negative supply for driving TFT-LCD panels mainly in smartphones and tablets. The device employs a single inductor scheme to provide a small bill-of-material and smallest PCB solution size.

It integrates a step-up DC-DC converter for preceding supply. An architecture with LDO and negative charge pump (NCP) generates dual outputs at +5.4V (default) and -5.4V (default), whose voltages can be programmed via an I<sup>2</sup>C compatible interface.

The device offers excellent line and load regulation performances, as well as load transient. It features an outstanding efficiency that is greater than 80% when  $I_{OUT} > 10\text{mA}$  and 85% when  $I_{OUT} > 40\text{mA}$ . With its input voltage range of 2.7V to 5.5V, it can be powered by single-cell batteries (Li-Ion, Ni-Li, Li-Polymer).

### Applications

TFT LCD Smartphones, Tablets and NB  
Dual Power Supply Application

### Typical Application Circuit

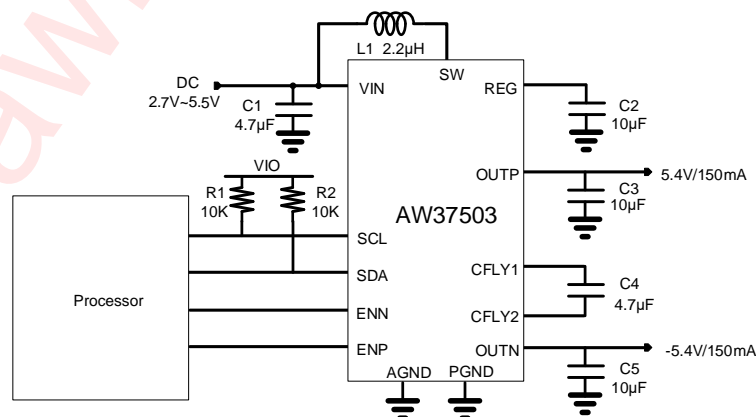
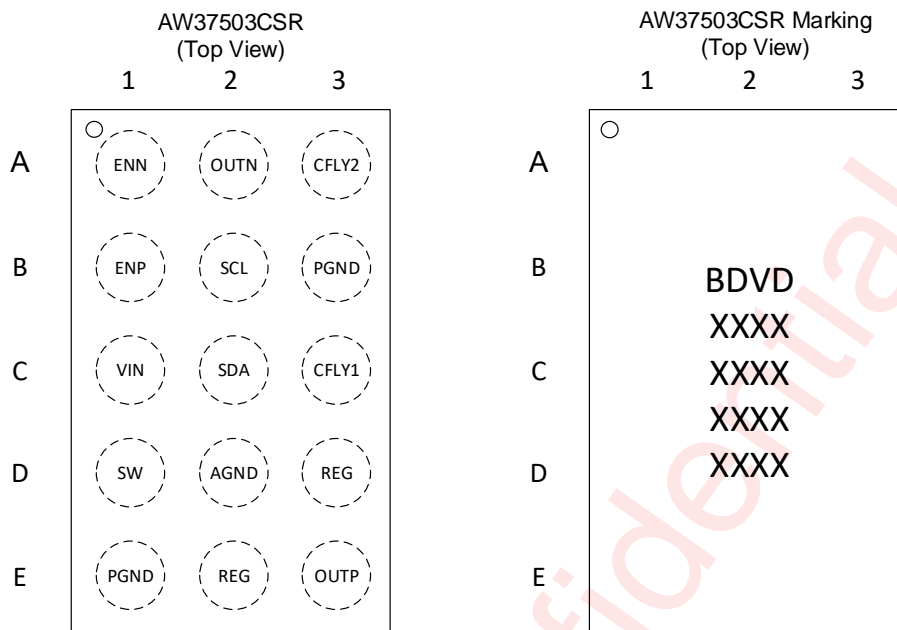


Figure 1 Typical Application Circuit of AW37503

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## Pin Configuration And Top Mark



BDVD - AW37503CSR Marking  
XXXX XXXX XXXX XXXX - Production Tracing Code

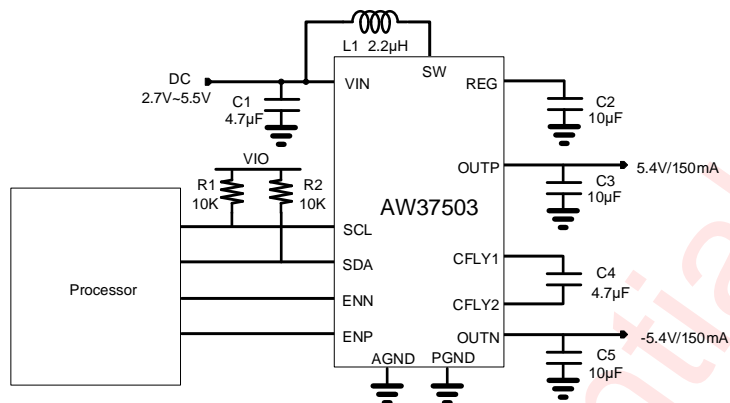
Figure 2 Pin Configuration and Top Mark

## Pin Definition

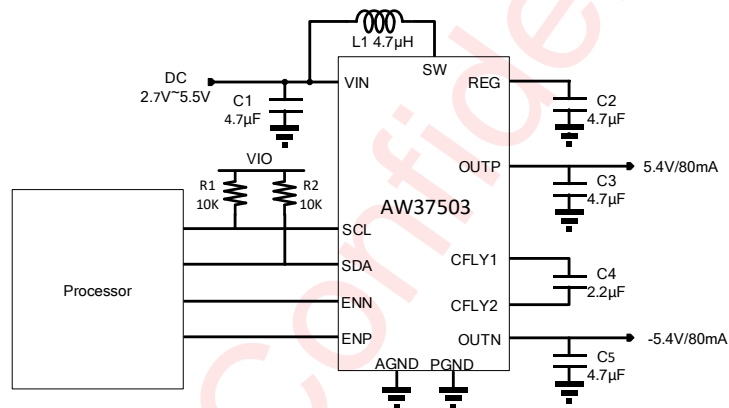
No.	NAME	DESCRIPTION
A1	ENN	Enable input for negative output (OUTN). A logic high enables the negative output, a logic low forces the output into shutdown.
A2	OUTN	Output pin of the negative charge pump.
A3	CFLY2	Negative charge pump flying capacitor pin.
B1	ENP	Enable Input for positive output (OUTP). A logic high enables the positive output, a logic low forces the output into shutdown.
B2	SCL	Clock input for the I <sup>2</sup> C serial interface.
B3	PGND	Power Ground.
C1	VIN	Power Input.
C2	SDA	Data input for the I <sup>2</sup> C serial interface.
C3	CFLY1	Negative charge pump flying capacitor pin.
D1	SW	Switch pin of the boost converter.
D2	AGND	Analog ground.
D3	REG	Boost converter output pin.
E1	PGND	Power Ground.
E2	REG	Boost converter output pin.
E3	OUTP	Output pin of the LDO.



## Typical Application Circuits



(a) Suitable for 80mA Mode and 150mA Mode



(b) Suitable for 80mA Mode, and  $I_{OUT} < 40mA$

**Figure 4 AW37503 Application circuits**

### Notice for typical application circuits:

- All peripheral devices should be as closed as possible to the chip, C1、C2、C3、C4、C5 and L1 should be closed to VIN、REG、OUTP、CFLY1/2 and OUTN pins respectively. Besides the metal traces between them should be short and wide.
- The inductor recommended 2.2 $\mu$ H is suitable for 80mA and 150mA Mode application for better efficiency.
- The input capacitor C1 can be larger values; the output capacitors C2, C3 and C5 should be selected in recommended values, the larger value of C2, C3 and C5, the smaller of the ripple voltage, but the longer of starting time; the flying capacitor C4 can be larger, but overlarge value may cause large inrush current during startup.

## Ordering Information

Part Number	Temperature	Package	Marking	Moisture Sensitivity Level	Environmental Information	Delivery Form
AW37503CSR	-40°C~85°C	WLCSP 1.27mmX2.00mm X0.625mm-15B	BDVD	MSL1	ROHS+HF	3000 units/ Tape and Reel

## Absolute Maximum Ratings<sup>(NOTE1)</sup>

PARAMETERS		RANGE
Supply voltage range $V_{IN}$		-0.3V to 6V
Input voltage range	ENN, ENP, SDA, SCL	-0.3V to $V_{IN}+0.3V$
Output voltage range	SW	-0.3V to 8V
	REG, CFLY1	-0.3V to 8V
	OUTP	-0.3V to 7V
	CFLY2, OUTN	-7V to 0.3V
Junction-to-ambient thermal resistance $\theta_{JA}$		91.5°C/W
Operating free-air temperature range		-40°C to 85°C
Maximum operating junction temperature $T_{JMAX}$		150°C
Storage temperature $T_{STG}$		-65°C to 150°C
Lead temperature (soldering 10 seconds)		260°C

NOTE1: Conditions out of those ranges listed in "absolute maximum ratings" may cause permanent damages to the device. In spite of the limits above, functional operation conditions of the device should within the ranges listed in "recommended operating conditions". Exposure to absolute-maximum-rated conditions for prolonged periods may affect device reliability.

## ESD Rating and Latch Up

PARAMETERS	VALUE	UNIT
HBM (Human Body Model) <sup>(NOTE 2)</sup>	±2	kV
CDM <sup>(NOTE 3)</sup>	±1.5	kV
Latch-Up <sup>(NOTE 4)</sup>	+IT: 200; -IT: -200	mA

NOTE2: The human body model is a 100pF capacitor discharged through a 1.5kΩ resistor into each pin. Test method: ESDA/JEDEC JS-001-2017

NOTE3: Test method: ESDA/JEDEC JS-002-2018

NOTE4: Test method: JESD78E

## Recommended Components List

Component	DESCRIPTION	MIN.	TYP.	MAX.	UNIT
L1	Inductor		2.2		μH
C1	Input capacitor	4.7			μF
C2	REG output capacitor	4.7	10		μF
C4	Flying capacitor	2.2	4.7		μF
C3 & C5	OUTP and OUTN output capacitor	4.7	10		μF

## Electrical Characteristics

$V_{IN}=3.7V$ ,  $ENN=ENP=V_{IN}$ ,  $V_{OUTP}=5.4V$ ,  $V_{OUTN}=-5.4V$ ,  $T_A=25^{\circ}C$  for typical values (unless otherwise noted)

PARAMETER		TEST CONDITION	MIN	TYP	MAX	UNIT
<b>INPUT VOLTAGES and CURRENTS</b>						
$V_{IN}$	$V_{IN}$ supply voltage range		2.7		5.5	V
$V_{UVLO}$	Under-voltage lockout threshold	$V_{IN}$ rising	2.3	2.4	2.5	V
		$V_{IN}$ falling	2.1	2.2	2.3	V
$I_Q$	Quiescent current	$I_{OUT}=0mA$	0.6	0.83	1.2	mA
$I_{SD}$	Shutdown down current	$ENP=ENN=0V$		1	2	$\mu A$
<b>LOGIC ENN, ENP, SDA, SCL</b>						
$V_{IH}$	High level input voltage	$V_{IN}=2.5V$ to $5.0V$	1.2	1.5	2.0	V
$V_{IL}$	Low level input voltage				0.4	V
$V_{OL}$	Low level output voltage	$V_{IN}=2.5V$ to $5.0V$ , sinking $2mA$			0.4	V
$R_{EN}$	Pulldown resistors	$ENP$ and $ENN$ pull-down resistance	0.1	0.2	0.3	$M\Omega$
<b>BOOST CONVERTER CHARACTERISTICS</b>						
$I_{LIM}$	Boost converter valley current limit value		1.2	1.5	2.0	A
$F_{SW}$	Boost converter switching frequency		1.1	1.4	1.7	MHz
$T_{SS}$	Soft start-up time			0.2	1.0	ms
<b>LDO CHARACTERISTICS</b>						
$V_{OUTP}$	Positive output voltage range	In $100mV$ steps, no load	4.0		6.0	V
	Default output voltage	$I_{OUTP}=80mA$		5.4		V
	Positive output voltage accuracy	$I_{OUTP}<150mA$	-1.5		1.5	%
$I_{OUTP}$	Positive output current capability	$ENP=High$	200			mA
$I_{OUTP\_LIM}$	OUTP output current limit value	$REG04H[4]=0$	300	370	440	mA
		$REG04H[4]=1$	220	270	360	mA
$V_{DROP}$	Dropout voltage	$V_{REG}=V_{OUTP}=5.4V$ , $I_{OUTP}=150mA$	30	60	100	mV
$V_{LIP}$	OUTP line regulation	$V_{IN}=2.7V$ to $5.0V$ , $I_{OUTP}=80mA$		0.024	0.08	%/V
	OUTP line variation			3	10	mV
$V_{LOP}$	OUTP load regulation	$\Delta I_{OUTP}=80mA$		2	3	%/A
$R_{DISP}$	OUTP discharge resistor		40	60	100	$\Omega$
<b>NEGATIVE CHARGE PUMP CHARACTERISTICS</b>						
$V_{OUTN}$	Negative output voltage range	In $100mV$ steps, no load	-6.0		-4.0	V
	Default Output	$I_{OUTN}=80mA$		-5.4		V

PARAMETER		TEST CONDITION	MIN	TYP	MAX	UNIT
	Negative output voltage accuracy	$I_{OUTN} < 150\text{mA}$	-1.5		1.5	%
$I_{OUTN}$	Negative output current capability	REG03H[6]=0 , 80mA mode(default)	80		120	mA
		REG03H[6]=1 , 150mA mode	150		230	mA
$F_{NCP}$	Negative charge pump switching frequency		0.9	1.0	1.1	MHz
$V_{LIN}$	OUTN line regulation	$V_{IN}=2.7\text{V to }5.0\text{V}$ , $I_{OUTN}=80\text{mA}$		0.024	0.16	%/V
	OUTN line variation			3	20	mV
$V_{LON}$	OUTN load regulation	$\Delta I_{OUTN}=100\text{mA}$		8		%/A
$R_{DISN}$	OUTN discharge resistor		14	20	30	$\Omega$
<b>PROTECTION</b>						
$T_{OTP}$	Overheating shutdown temperature			140		$^{\circ}\text{C}$
	Thermal hysteresis for $T_{OTP}$			20		$^{\circ}\text{C}$

**I<sup>2</sup>C INTERFACE TIMING**

SYMBOL	DESCRIPTION	MIN	TYP	MAX	UNIT
$F_{SCL}$	Interface Clock Frequency			400	kHz
$t_{DEGLITCH}$	Deglitch Time	SCL		83	ns
		SDA		115	ns
$t_{HD:STA}$	(Repeat-Start) Start Condition Hold Time	0.6			$\mu\text{s}$
$t_{LOW}$	Low Level Width of SCL	1.3			$\mu\text{s}$
$t_{HIGH}$	High Level Width of SCL	0.6			$\mu\text{s}$
$t_{SU:STA}$	(Repeat-Start) Start Condition Setup Time	0.6			$\mu\text{s}$
$t_{HD:DAT}$	Data Hold Time	0			$\mu\text{s}$
$t_{SU:DAT}$	Data Setup Time	0.1			$\mu\text{s}$
$t_R$	Rising Time of SDA and SCL			0.3	$\mu\text{s}$
$t_F$	Falling Time of SDA and SCL			0.3	$\mu\text{s}$
$t_{SU:STO}$	Stop Condition Setup Time	0.6			$\mu\text{s}$
$t_{BUF}$	Time Between Start and Stop Condition	1.3			$\mu\text{s}$

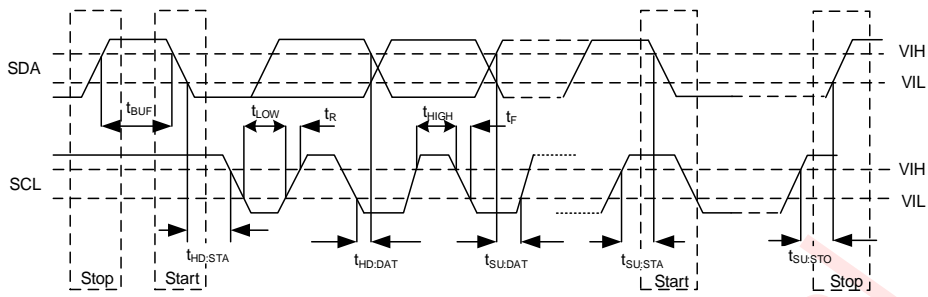


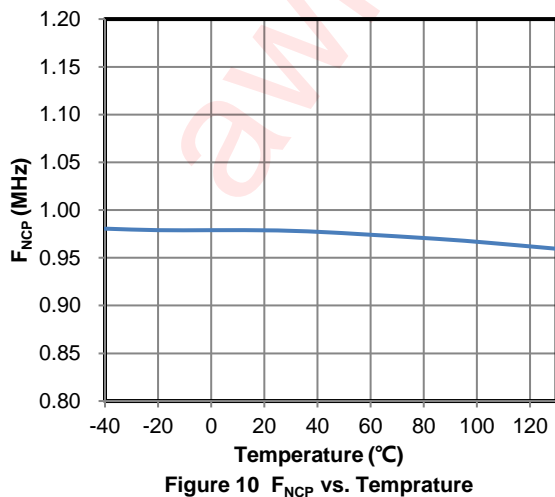
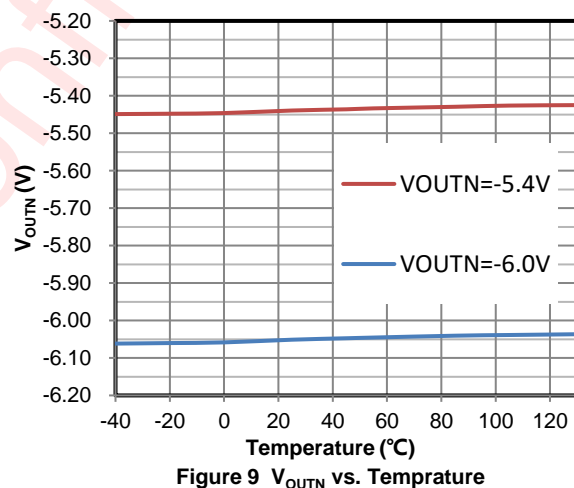
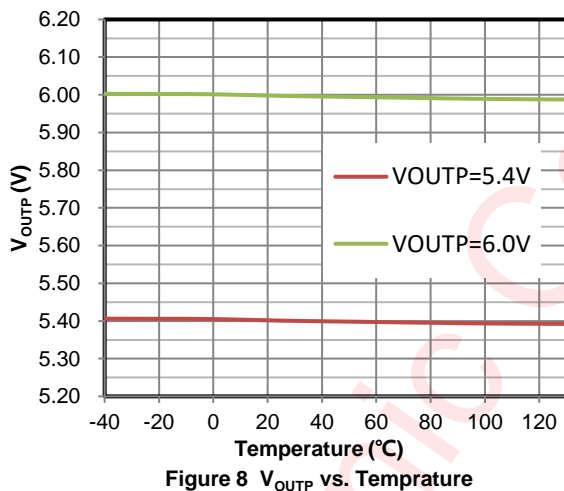
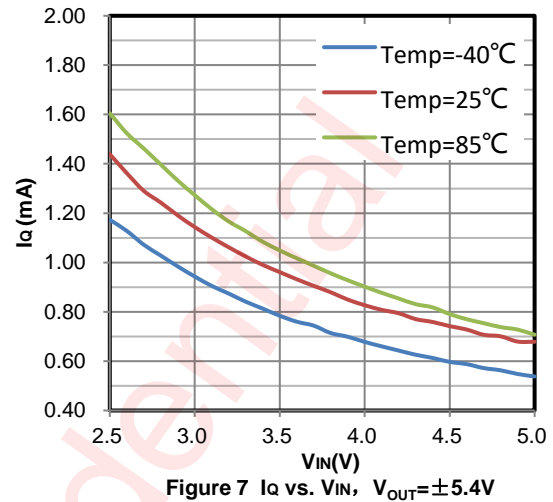
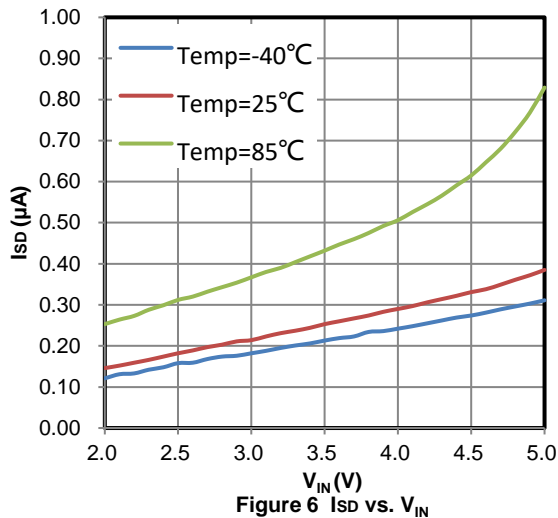
Figure 5 I<sup>2</sup>C Interface Timing

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## Typical Characteristics

$V_{IN}=3.7V$ ,  $ENN=ENP=V_{IN}$ ,  $V_{OUTP}=5.4V$ ,  $V_{OUTN}=-5.4V$ ,  $T_A=25^\circ C$ , Circuit of figure 4 unless other noted.



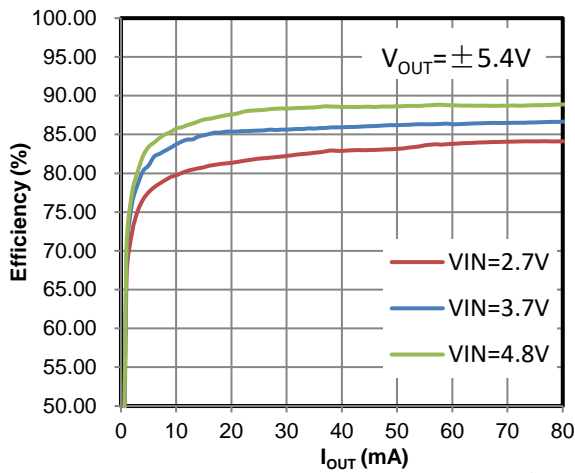


Figure 11 Efficiency (80mA Mode)

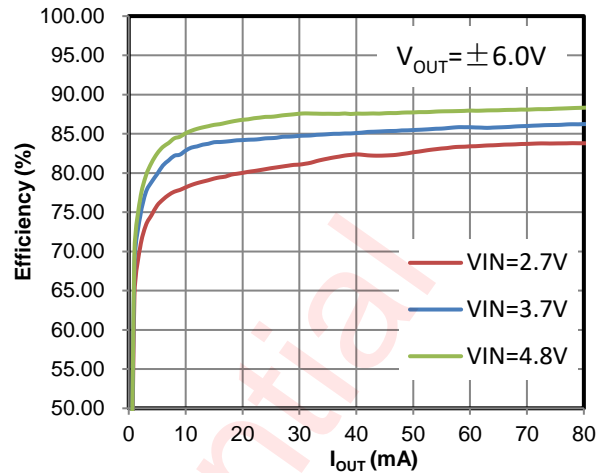


Figure 12 Efficiency (80mA Mode)

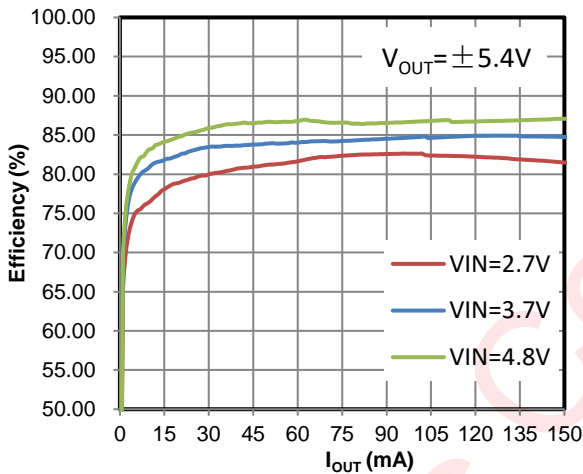


Figure 13 Efficiency (150mA Mode)

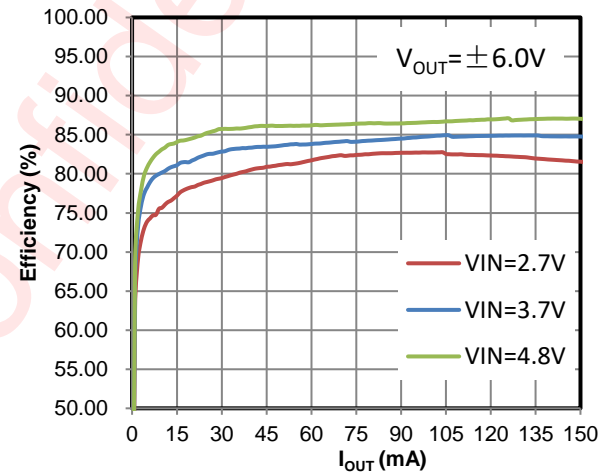


Figure 14 Efficiency (150mA Mode)

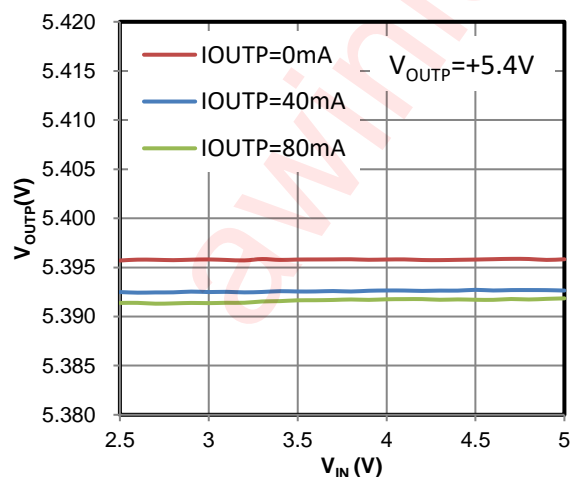


Figure 15 Line Regulation (80mA Mode)

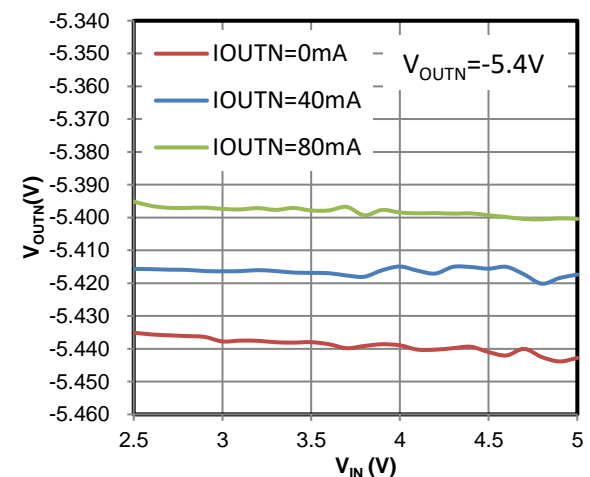


Figure 16 Line Regulation (80mA Mode)

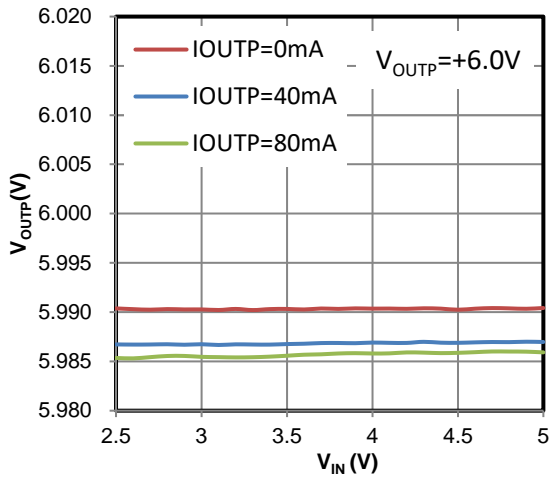


Figure 17 Line Regulation (80mA Mode)

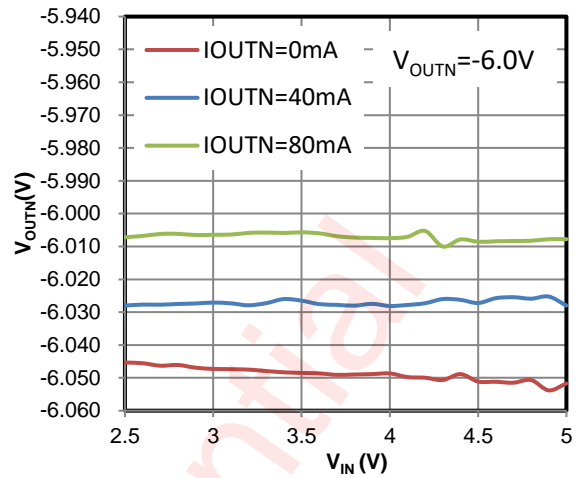


Figure 18 Line Regulation (80mA Mode)

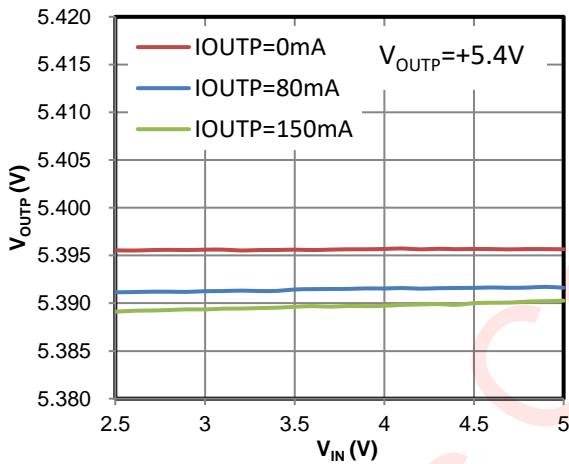


Figure 19 Line Regulation (150mA Mode)

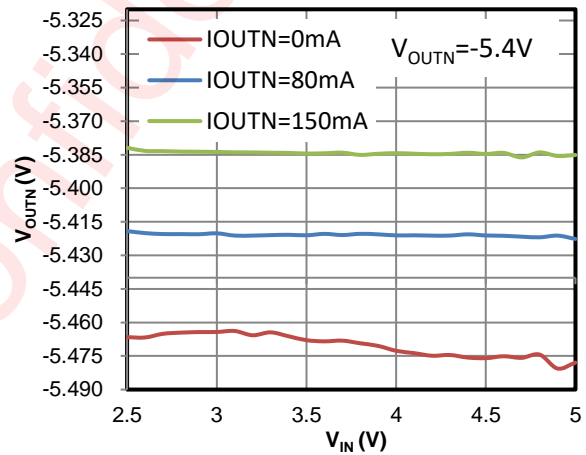


Figure 20 Line Regulation (150mA Mode)

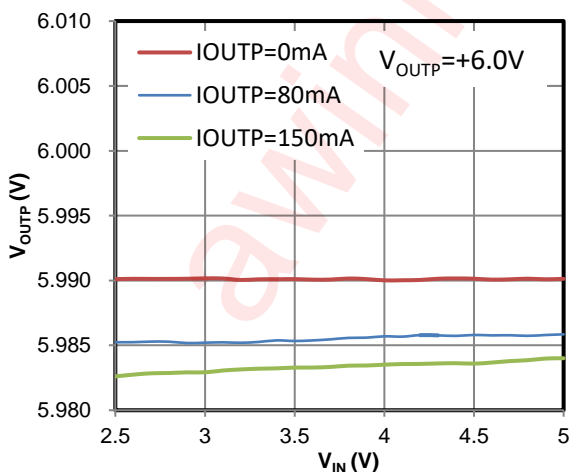


Figure 21 Line Regulation (150mA Mode)

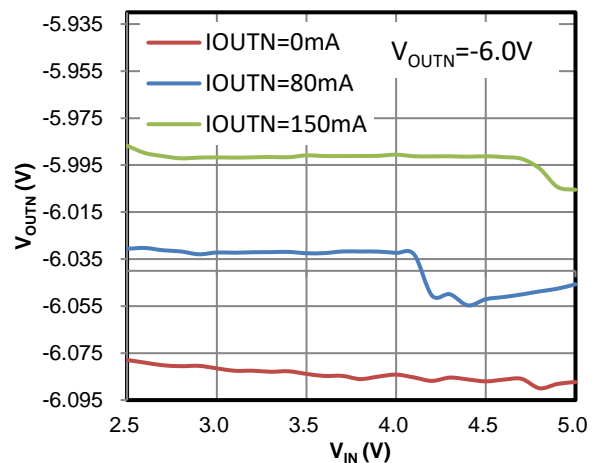


Figure 22 Line Regulation (150mA Mode)

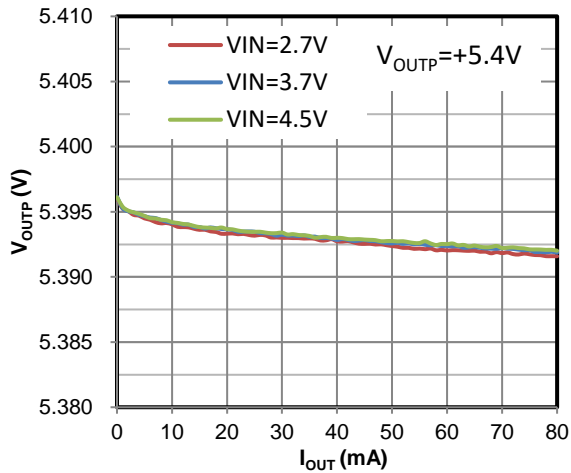


Figure 23 Load Regulation (80mA Mode)

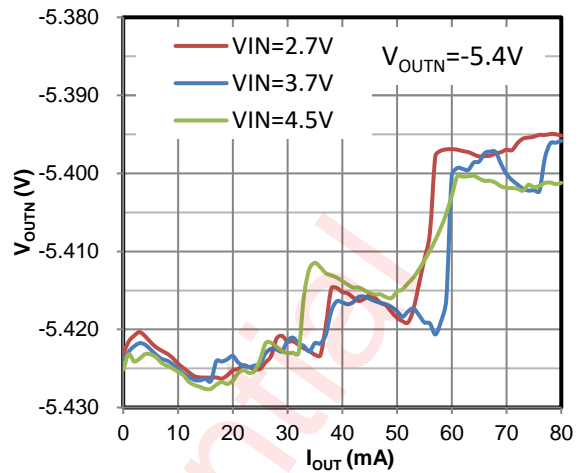


Figure 24 Load Regulation (80mA Mode)

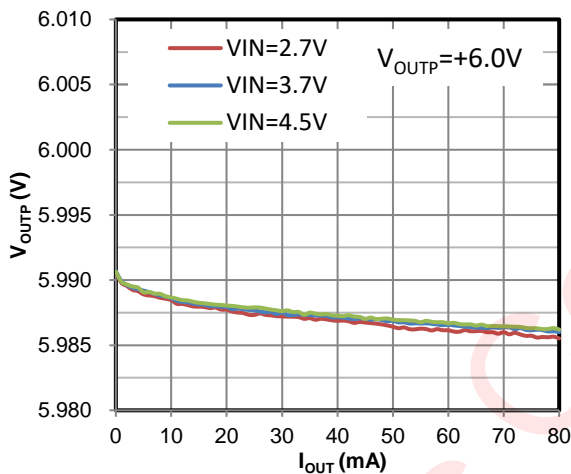


Figure 25 Load Regulation (80mA Mode)

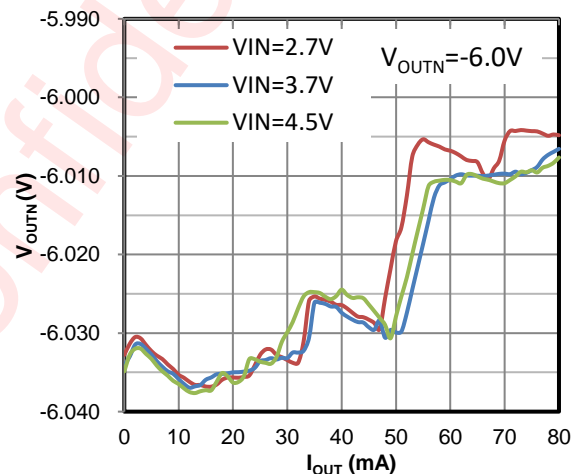


Figure 26 Load Regulation (80mA Mode)

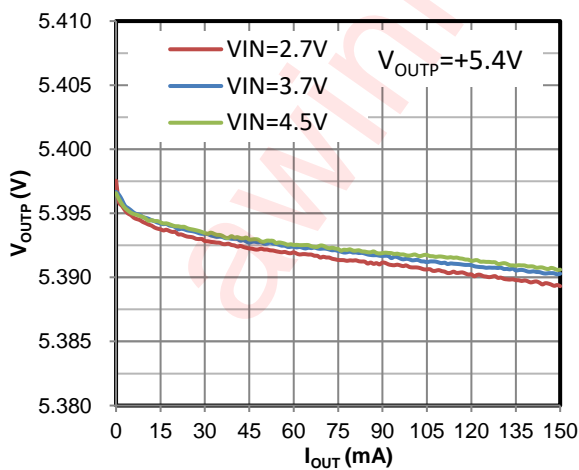


Figure 27 Load Regulation (150mA Mode)

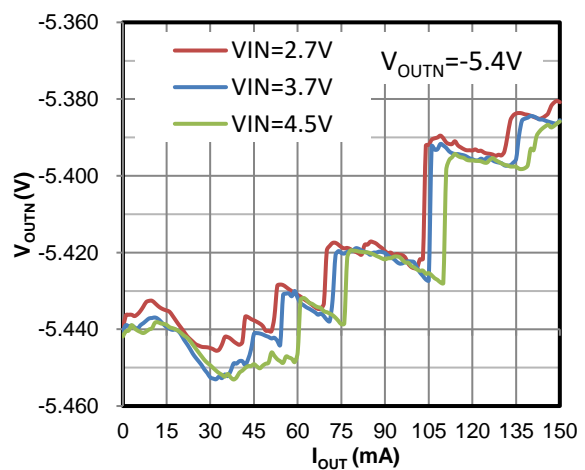


Figure 28 Load Regulation (150mA Mode)

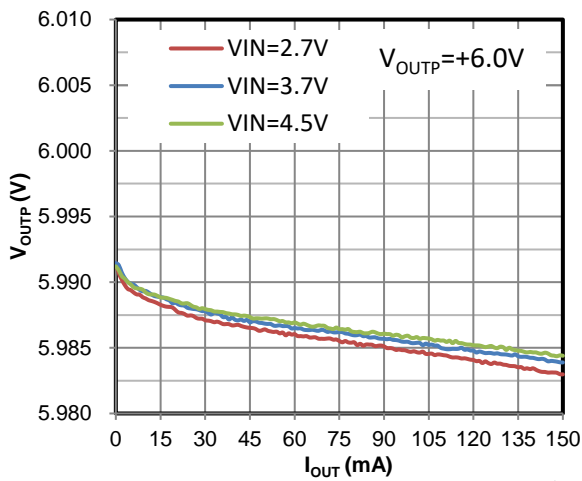


Figure 29 Load Regulation (150mA Mode)

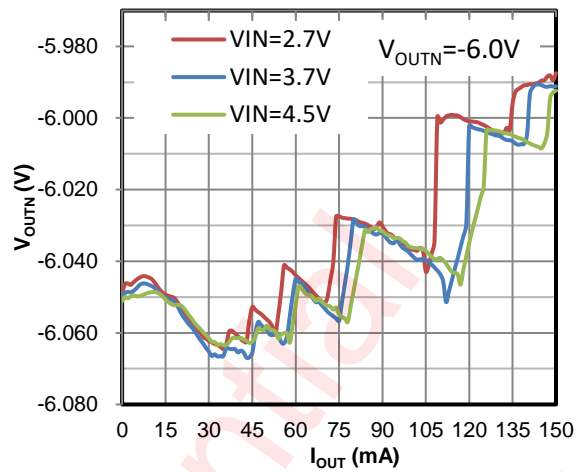


Figure 30 Load Regulation (150mA Mode)

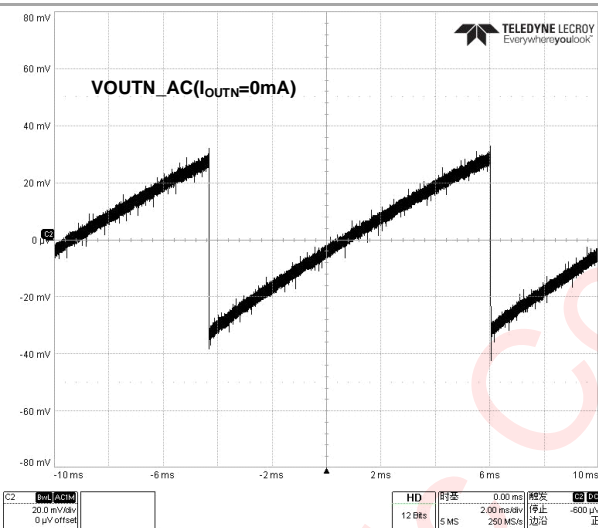


Figure 31  $V_{OUTN}$  Output Voltage Ripple (80mA Mode)

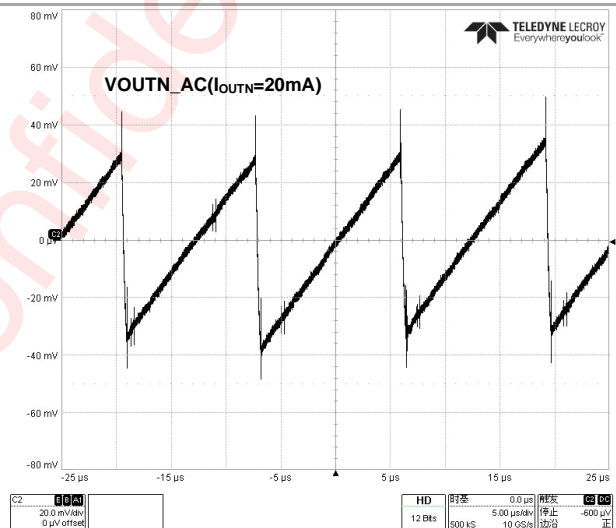


Figure 32  $V_{OUTN}$  Output Voltage Ripple (80mA Mode)

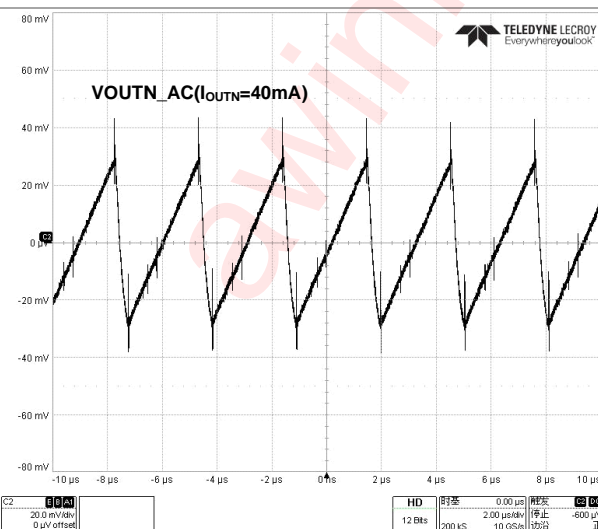


Figure 33  $V_{OUTN}$  Output Voltage Ripple (80mA Mode)

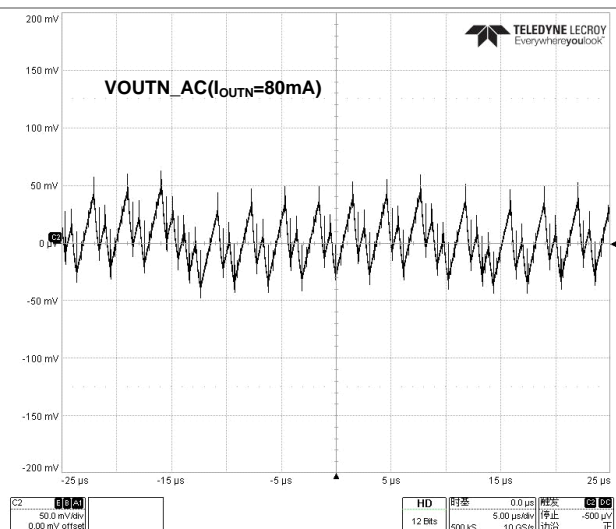


Figure 34  $V_{OUTN}$  Output Voltage Ripple (80mA Mode)

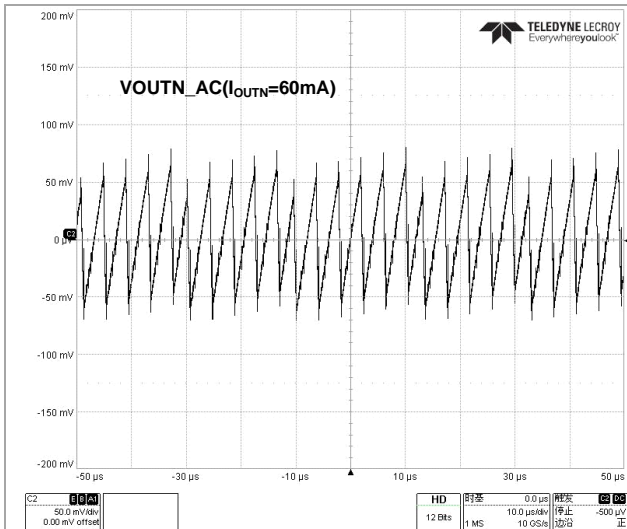


Figure 35 V<sub>OUTN</sub> Output Voltage Ripple(150mA Mode)

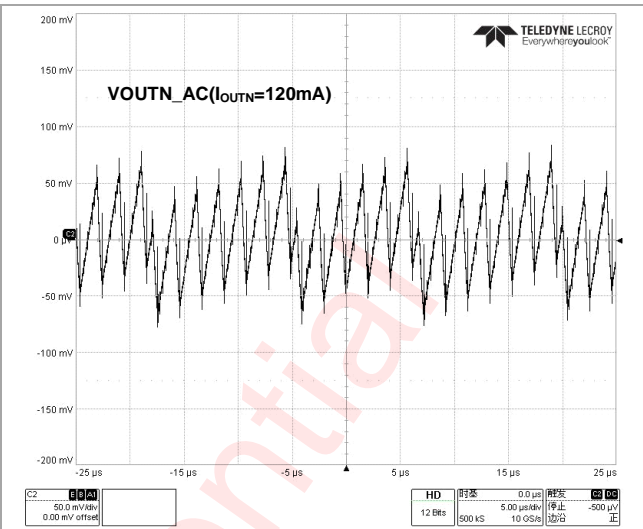


Figure 36 V<sub>OUTN</sub> Output Voltage Ripple(150mA Mode)

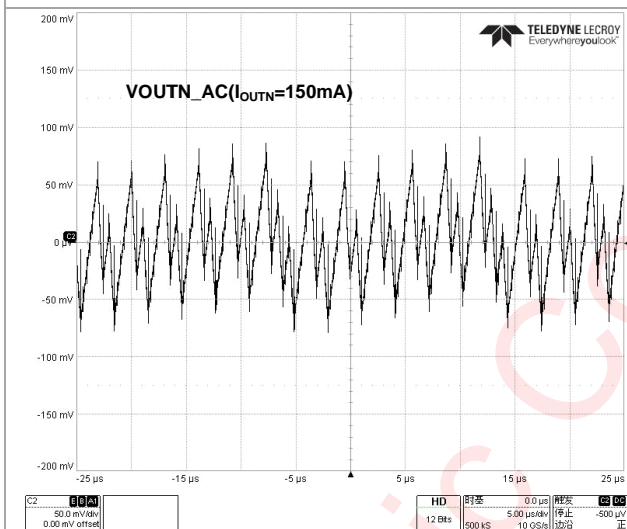


Figure 37 V<sub>OUTN</sub> Output Voltage Ripple(150mA Mode)

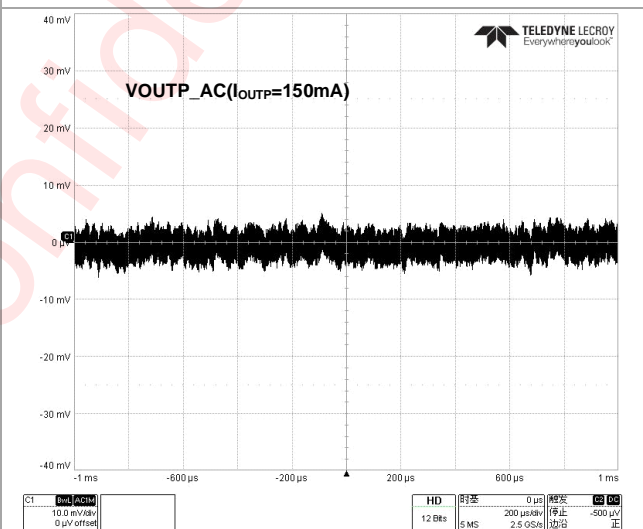


Figure 38 V<sub>OUTP</sub> Output Voltage Ripple

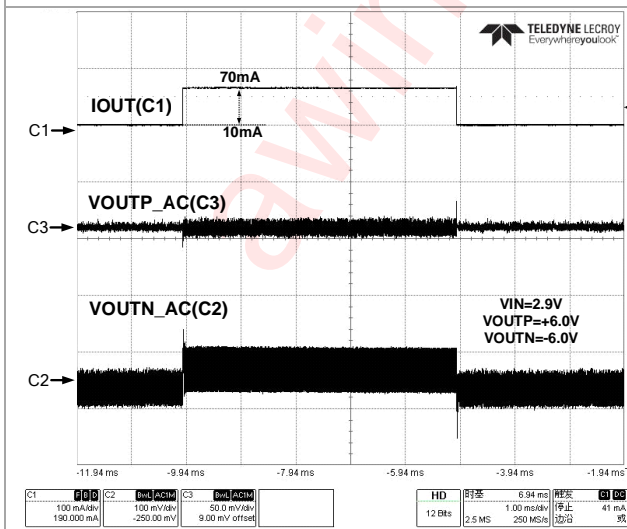


Figure 39 Load Transient(80mA Mode)

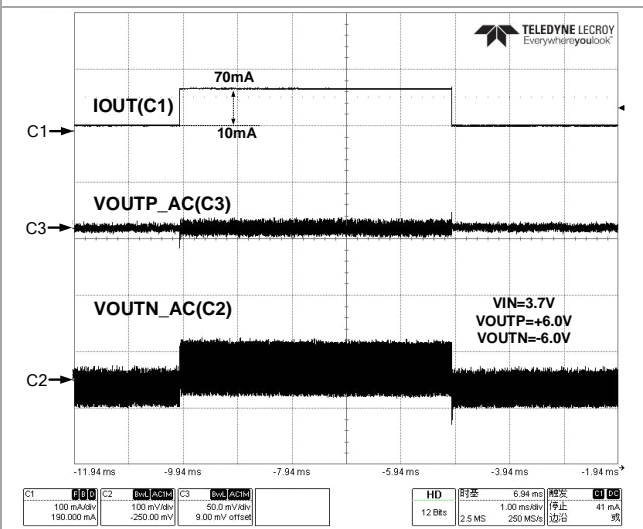


Figure 40 Load Transient(80mA Mode)



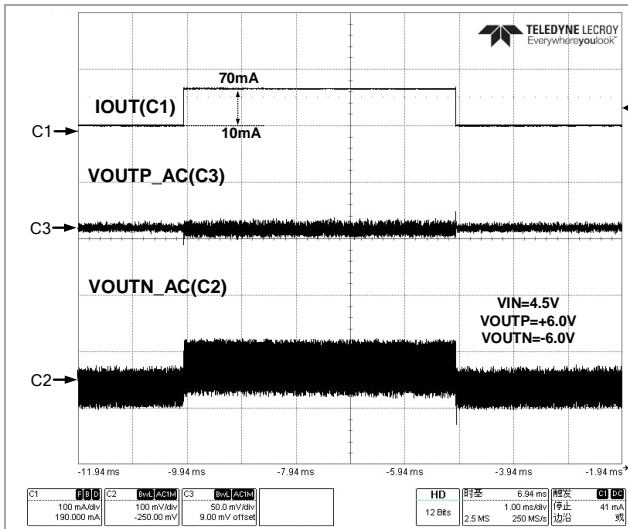


Figure 41 Load Transient(80mA Mode)

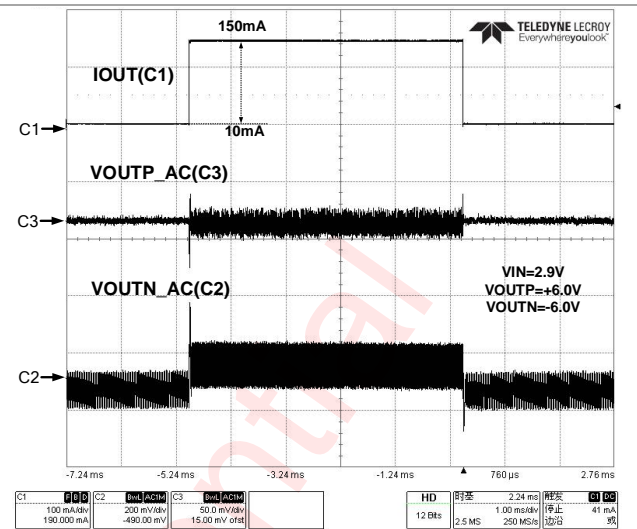


Figure 42 Load Transient(150mA Mode)

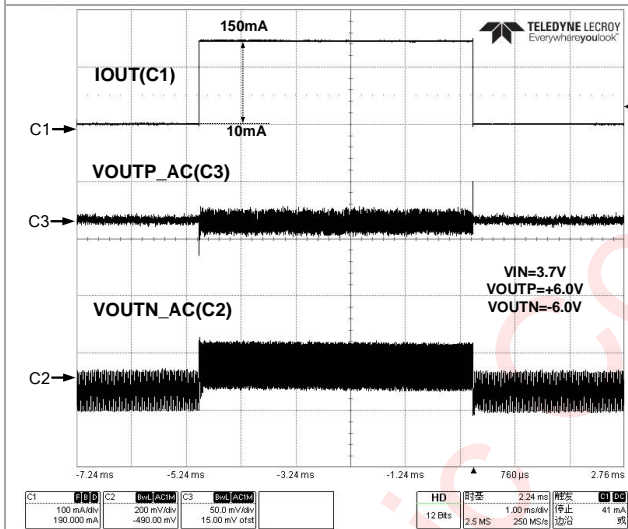


Figure 43 Load Transient(150mA Mode)

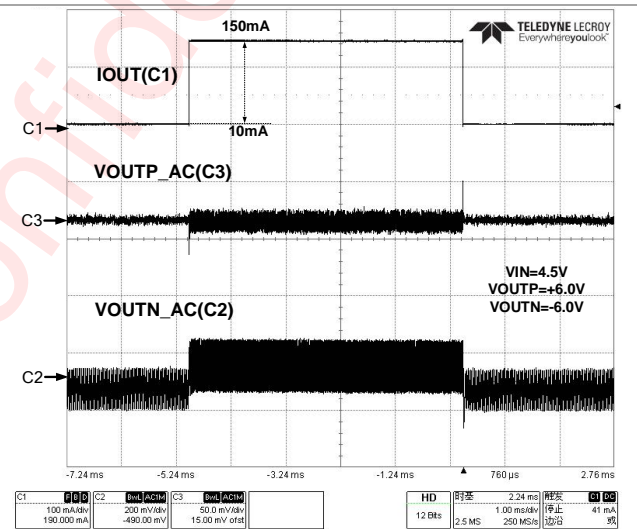


Figure 44 Load Transient(150mA Mode)

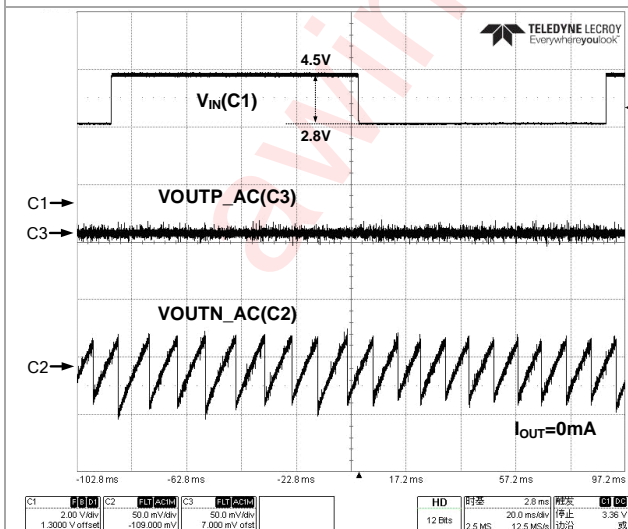


Figure 45 Line Transient (80mA Mode)

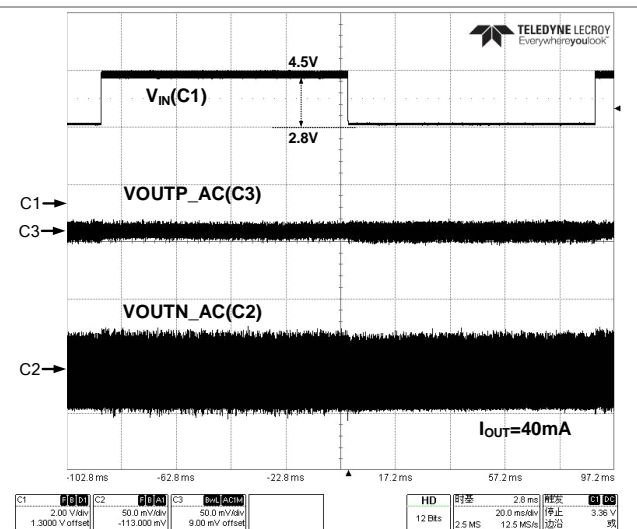


Figure 46 Line Transient (80mA Mode)

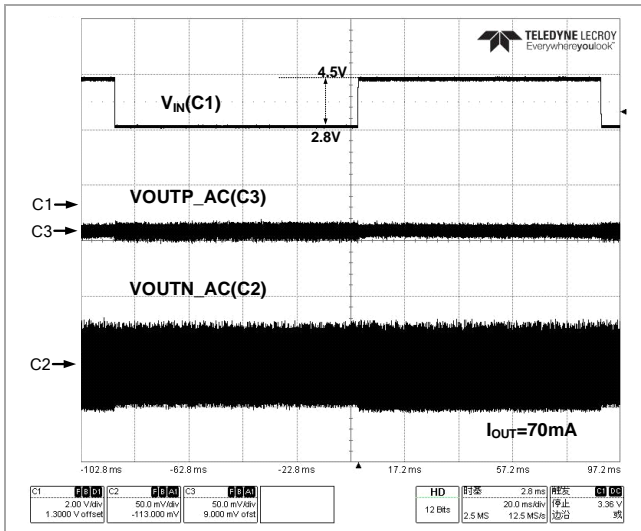


Figure 47 Line Transient (80mA Mode)

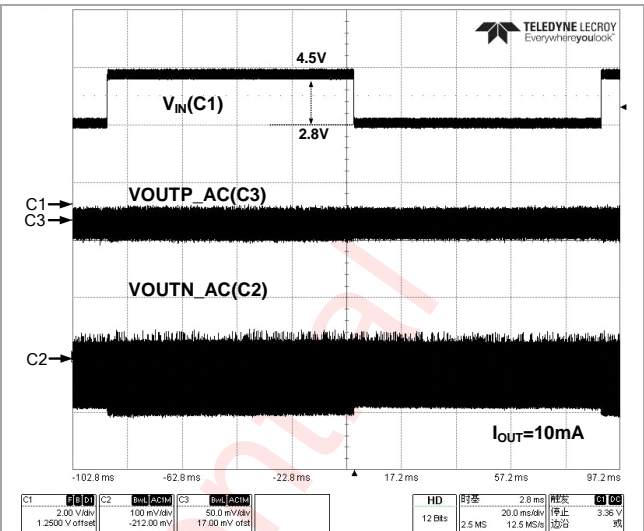


Figure 48 Line Transient (150mA Mode)

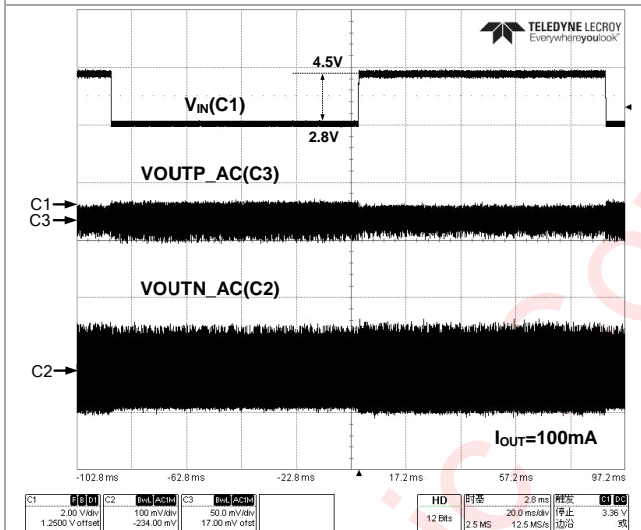


Figure 49 Line Transient (150mA Mode)

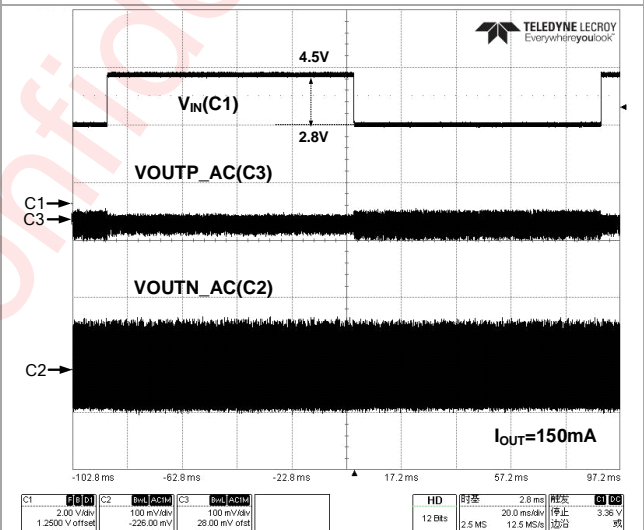


Figure 50 Line Transient (150mA Mode)

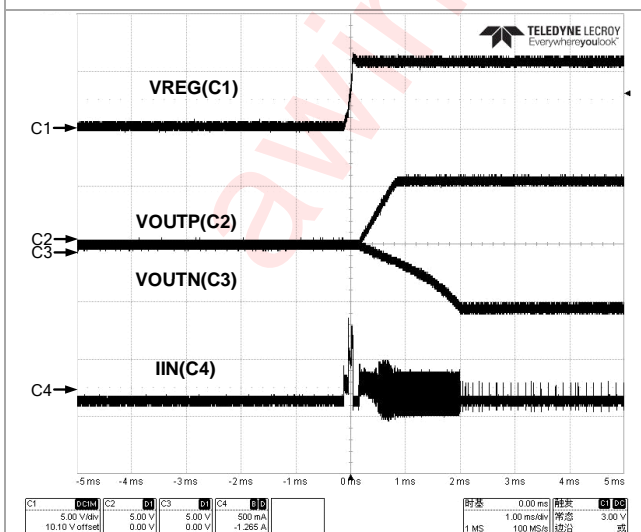


Figure 51 Inrush Current (Simultaneous)

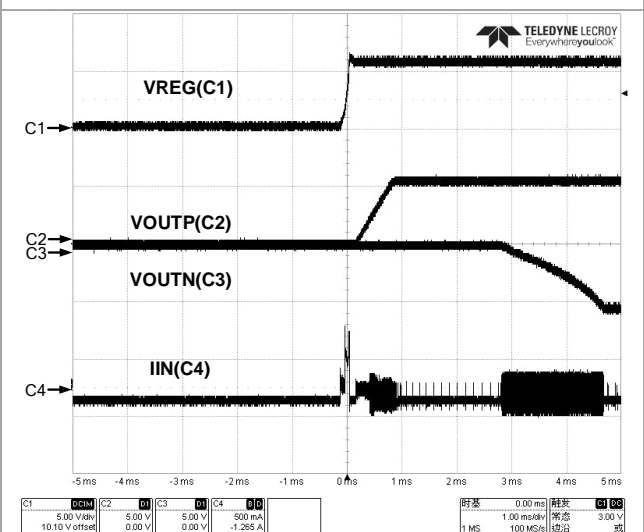


Figure 52 Inrush Current (Sequential)



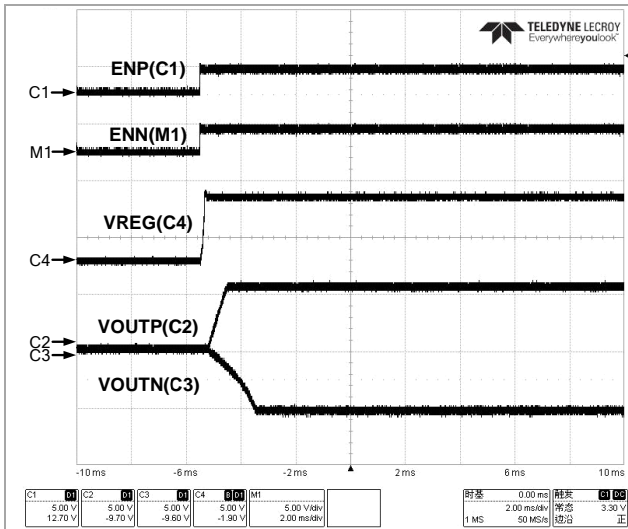


Figure 53 Power Up Sequencing (Simultaneous)

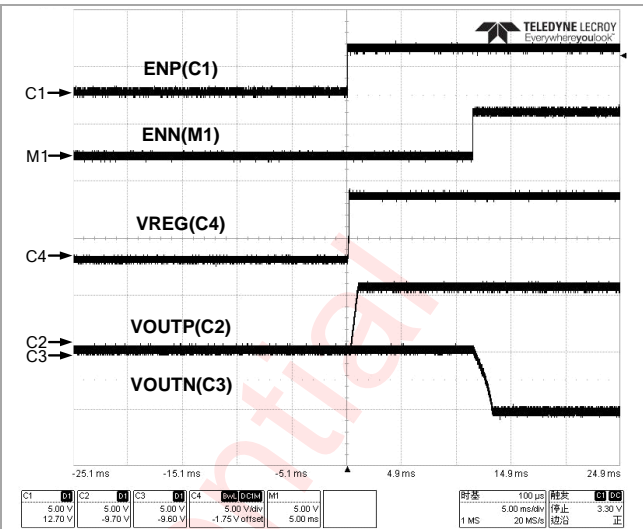


Figure 54 Power Up Sequencing (Sequential)

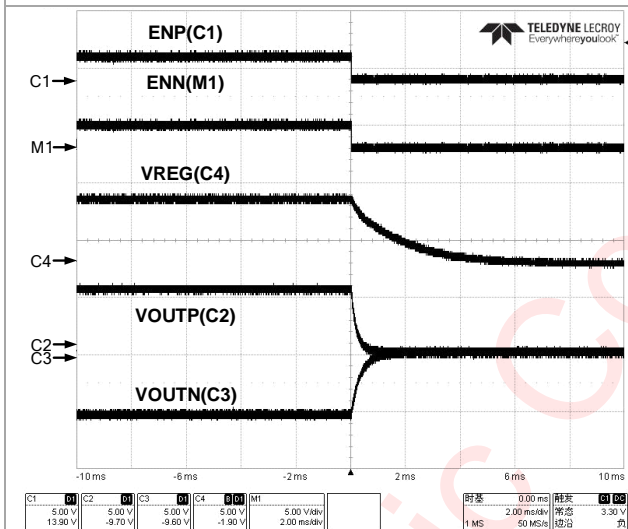


Figure 55 Power Down Sequencing (Simultaneous)

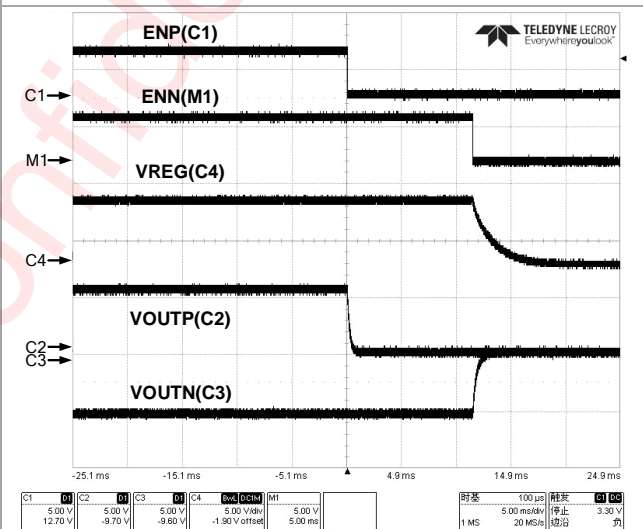


Figure 56 Power Down Sequencing (Sequential)

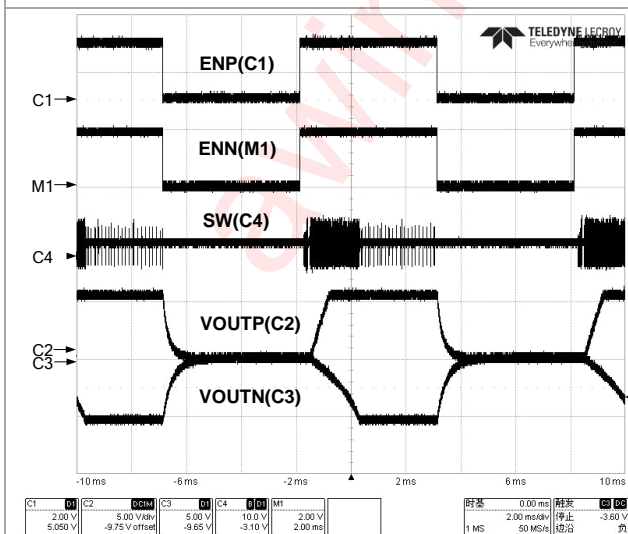


Figure 57 Power Up/Down With Active Discharge

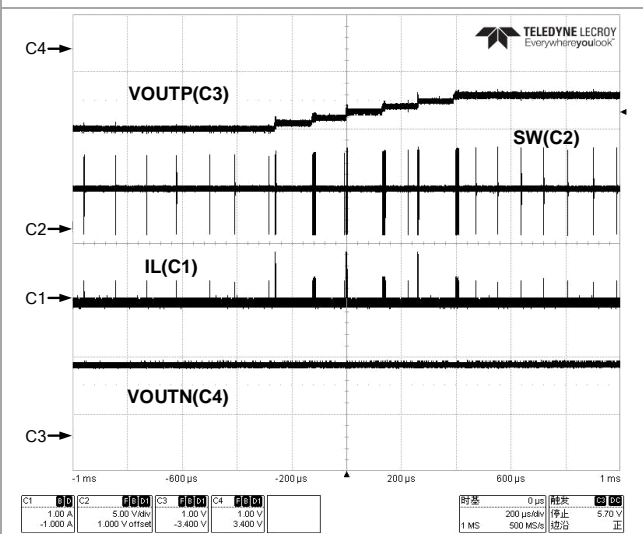
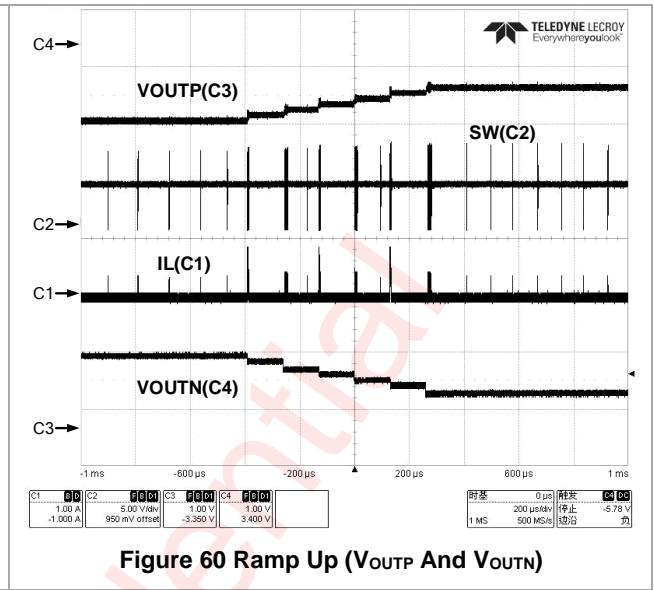
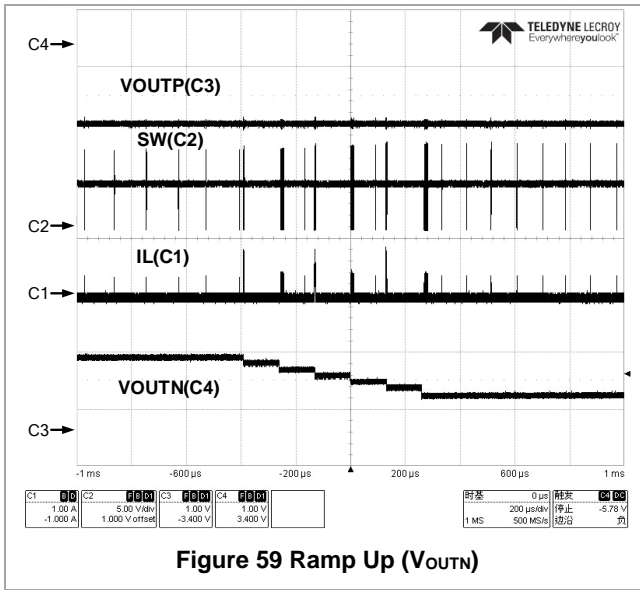


Figure 58 Ramp Up (VOUT)



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## Detailed Functional Description

AW37503 is designed to generate both positive and negative bias voltages for TFT-LCD panels or other general dual power supply applications. It consists a highly integrated synchronous boost converter with input voltage range from 2.7V to 5.5V. An internal LDO drops down the output voltage of the boost converter ( $V_{REG}$ ), delivering the positive supply from +4.0V to +6.0V (100mV/step). A charge pump inverts and regulates the output voltage of the boost converter ( $V_{REG}$ ), providing the negative supply from -4.0V to -6.0V (100mV/step). The operating mode can be selected between 80mA and 150mA in order to achieve the necessary current capability and to get the best efficiency performance based on the application.

### Enabling and Disabling the Device

ENP and ENN separately control positive output ( $V_{OUTP}$ ) and negative output ( $V_{OUTN}$ ) enable or disable. When  $V_{IN}$  is above the UVLO threshold, ENP or ENN goes to a logic-high, the boost converter will start up firstly and then the positive or negative voltage output. The boost converter is turned off when both ENP and ENN are low or  $V_{IN}$  falls below the UVLO stop threshold. Both ENP pin and ENN pin have an internal 200K $\Omega$  pull-down resistance to ground.

### Power-Up and Soft-Start

When  $V_{IN}$  is above UVLO threshold and ENN or ENP is pulled to high voltage, the boost converter is enabled. To avoid drawing high inrush current from a battery or high impedance power source during startup, the boost converter employs an internal soft-start feature.

During boost's soft start, inductance current is limited in two ways. When  $V_{REG} < 1.2V$ , the low side power transistor of boost is turned on for fixed on time and switching period, and the inductance current is DCM state; when  $V_{REG} > 1.2V$ , boost works in the low valley current limiting state; when  $V_{REG}$  reaches the target voltage, the boost converter has reached its power good, which means that boost output is established, soft start is finished, and LDO and charge pump are allowed to work after 60 $\mu$ s delay.

The LDO starts operating as soon as the ENP signal is pulled HIGH, when the boost converter has reached its power good threshold. The LDO integrates a soft-start that slowly ramps up its output voltage  $V_{OUTP}$  regardless of the output capacitor and the target voltage, as long as the LDO current limit is not reached. The typical ramp-up time is 500 $\mu$ s.

The charge pump starts operating as soon as the ENN signal is pulled HIGH, when the boost converter has reached its power good threshold. The charge pump integrates a soft-start that slowly ramps up its output voltage  $V_{OUTN}$  regardless of the output capacitor and the target voltage, the charge pump current is limited and the limit current can be configured by REG03H[6].

The LDO and charge pump can be turn on via configuring REG03H[4:3] and REG21H, the REG21H is the written protect register of REG03H[4:3]. The detail function of REG03H[4:3] is described as below:

#### Power Control

REG03H[4]: ENN = Enable OUTN output. Default is OFF.

REG03H[3]: ENP = Enable OUTP output. Default is OFF.

Note: Turning ON either the OUTP or OUTN output will also turn-on the boost converter for the REG voltage.

### Power-Down and Discharge

The BOOST, LDO and NCP stop operating when  $V_{IN}$  falls below the UVLO threshold (usually 2.2V) or when both ENP and ENN are pulled low. The LDO stops operating when only ENP is pulled down while BOOST and NCP can still work, the same as NCP when ENN is pulled down. Both OUTP and OUTN can be actively discharged to GND by setting controlling bits DISP and DISN of REG03H with an approximately 60 $\Omega$  and 20 $\Omega$  discharging resistors respectively. If programmed to be active, when the enable signals go low or  $V_{IN}$  falls below UVLO, the discharge will occur during power down.

### **Programmable OOTP and OUTN Voltage**

The OOTP positive output voltage is generated from the LDO supplied from a synchronous Boost converter, and OOTP is set at a default value of 5.4V. The boost converter also drives an inverting charge pump to generate OUTN negative output voltage which is set at a default value of -5.4V. The dual output voltages can be respectively programmed via a I<sup>2</sup>C interface, and the available voltage ranges are from +4V to +6V for OOTP and from -4V to -6V for OUTN with 100mV per step.

### **BOOST Converter Output Voltage and Efficiency Improvement**

The output voltage of boost is adjusted automatically based on the output voltages of LDO and charge pump. In order to achieve good efficiency and overall ripple effect, select the higher between  $V_{OOTP}$  and  $|V_{OUTN}|$ , and accumulate according to the current gear configuration. 200mV will be increased if 80mA mode is configured; 400mV will be increased if 150mA mode is configured.

In 80mA mode,

$$V_{REG} = \max(V_{OOTP}, |V_{OUTN}|) + 200 \text{ mV}$$

In 150mA mode,

$$V_{REG} = \max(V_{OOTP}, |V_{OUTN}|) + 400 \text{ mV}$$

In order to improve the efficiency, when boost works in DCM state, once the inductance current reaches 0A, it will enter the skip cycle mode and stop switching. When the output voltage is lower than the output regulation value, the switching will be restore again for realizing the constant voltage output. This mechanism can achieve the power saving effect under light load.

### **Under Voltage Lockout (UVLO)**

To avoid the mistaken operation of the IC at low input voltage, an under voltage lockout is designed which shuts down the device at voltage lower than the typical UVLO threshold of 2.2V. A hysteresis of 200mV is added so that the device cannot be enabled again until the input voltage goes up to 2.4V. This hysteresis voltage avoids unusual shutdown due to broad line transients when the battery gets suddenly heavily loaded. The serial interface I<sup>2</sup>C is still functional in the UVLO stop condition and the I<sup>2</sup>C registers' contents is only reset under POR, which is lower than UVLO stop condition.

### **Overvoltage Protection**

The output voltage of the boost converter ( $V_{REG}$ ) is monitored with an overvoltage protection comparator, as soon as the OVP threshold of 7.3V is reached, the device stops switching. The device starts operation again once the output voltage falls 0.12V below the overvoltage threshold.

### **Over Current Protection**

The AW37503 features a valley current limit sensing scheme to prevent from the BOOST is over loading. Current limit detection occurs during on-time of the synchronous rectifier cycle by cycle. When the inductor current is above the current limit within the whole switching cycle time, the off-time is increased to allow the inductor current to decrease to its threshold before the next on-time begins. When the current limit is reached, the output voltage  $V_{REG}$  will decreases if the load further increases. If  $V_{REG}$  is approximately below 1.2V during unexpected short circuit event, the boost converter works in discontinuous conduction mode to decrease the current from the battery. Once the short circuit event is released, the boost restarts.

The device also has an internal current limit circuit to help protect the LDO. During transient high-load current events, the OOTP sources a limited current of 370mA or 270mA, which is largely independent of the voltage at OOTP and can be configured via REG04H[4]. But if the output voltage of OOTP drops to 60% of the target value and over loading continues 32ms, this chip will shut down.

**OUTN Output Current Limit**

The OUTN built-in output current limit prevents the charge pump from over loading and OUTN short condition. The current limit threshold is decided by current mode set by REG03H[6].

Current mode	Current limit threshold
80mA mode	>80mA
150mA mode	>150mA

**Thermal Shutdown**

The device has a built-in temperature sensor which monitors the internal junction temperature. When the junction temperature exceeds 140°C, IC shuts down. When the junction temperature falls below the thermal recovery temperature, approximately 120°C, the device restarts by using the soft-start sequence.

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## General I<sup>2</sup>C Operation

The device supports the I<sup>2</sup>C serial bus and data transmission protocol. It operates as a slave on the I<sup>2</sup>C bus. The maximum clock frequency specified by the I<sup>2</sup>C standard is 400kHz. Connect to the bus are made via the open-drain I/O pins SCL and SDA. The pull-up resistor can be selected in the range of 1k~10kΩ and the typical value is 4.7kΩ when I<sup>2</sup>C frequency is 400kHz. Different high level from 1.2V to 5V of this I<sup>2</sup>C interface is supported.

## Device Address

AW37503 7-bit slave address (A7~A1) is 0111110 binary(0x3EH). After the START condition, the I<sup>2</sup>C master sends the 7-bit chip address followed by an eighth (A0) read or write bit (R/W). R/W= 0 indicates a WRITE function and R/W = 1 indicates a READ function.

Table 5. Device Address

A7	A6	A5	A4	A3	A2	A1	A0
0	1	1	1	1	1	0	R/W

## I<sup>2</sup>C Start/Stop

I<sup>2</sup>C start: SDA changes from high level to low level when SCL is high level.

I<sup>2</sup>C stop: SDA changes from low level to high level when SCL is high level.

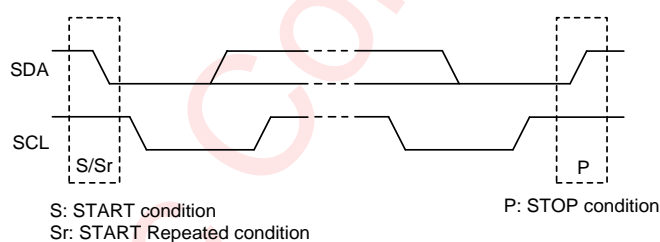


Figure 61 I<sup>2</sup>C Start/Stop Condition Timing

## Data Validation

When SCL is high level, SDA level must be constant. SDA can be changed only when SCL is low level.

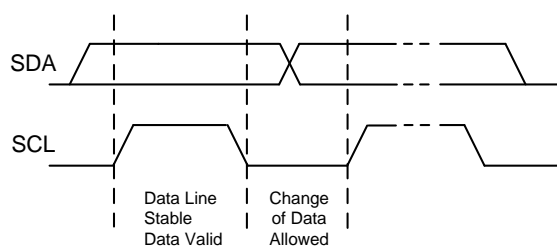


Figure 62 Data Validation Diagram

## ACK (Acknowledgement)

ACK means the successful transfer of I<sup>2</sup>C bus data. After master sends an 8-bit data, SDA must be released; SDA is pulled to GND by slave device when slave acknowledges.

When master reads, slave device sends 8-bit data, releases the SDA and waits for ACK from master. If ACK is send and I<sup>2</sup>C stop is not send by master, slave device sends the next data. If ACK is not send by master, slave device stops to send data and waits for I<sup>2</sup>C stop.

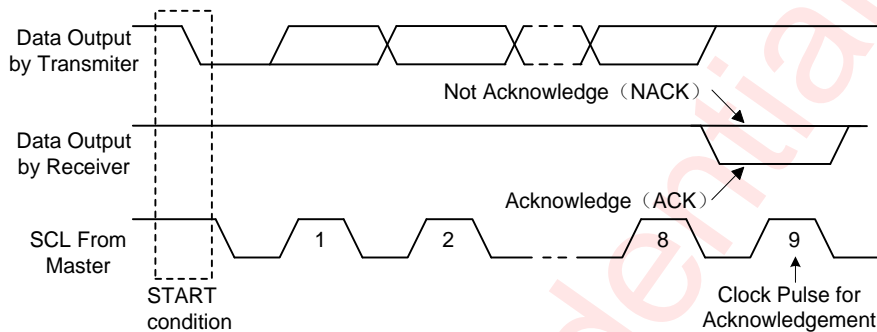


Figure 63 I<sup>2</sup>C ACK Timing

## Write Cycle

One data bit is transferred during each clock pulse. Data is sampled during the high state of the serial clock (SCL). Consequently, throughout the clock's high period, the data should remain stable. Any changes on the SDA line during the high state of the SCL and in the middle of a transaction, aborts the current transaction. New data should be sent during the low SCL state. This protocol allows a single data line to transfer both command/control information and data using the synchronous serial clock.

Each data transaction is composed of a start condition, a number of byte transfers (set by the software) and a stop condition to terminate the transaction. Every byte written to the SDA bus must be 8 bits long and is transferred with the most significant bit first. After each byte, an Acknowledge signal must follow.

In a write process, the following steps should be followed:

- Master device generates START condition. The "START" signal is generated by lowering the SDA signal while the SCL signal is high.
- Master device sends slave address (7-bit) and the data direction bit (R/W = 0).
- Slave device sends acknowledge signal if the slave address is correct.
- Master sends control register address (8-bit)
- Slave sends acknowledge signal
- Master sends data byte to be written to the addressed register
- Slave sends acknowledge signal
- If master will send further data bytes, the control register address will be incremented by one after acknowledge signal (repeat step f and g)
- Master generates STOP condition to indicate write cycle end

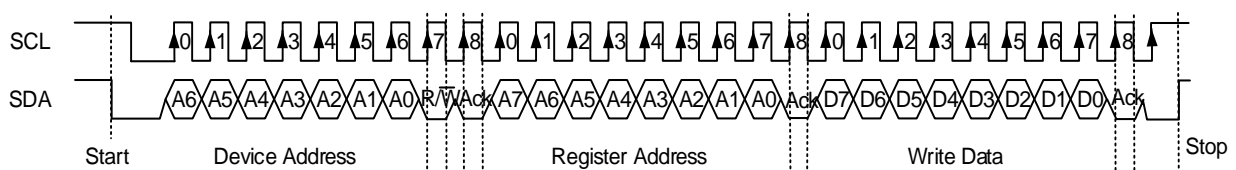


Figure 64 I<sup>2</sup>C Write Byte Cycle



## Read Cycle

In a read cycle, the following steps should be followed:

- Master device generates START condition
- Master device sends slave address (7-bit) and the data direction bit (R/W = 0).
- Slave device sends acknowledge signal if the slave address is correct.
- Master sends control register address (8-bit)
- Slave sends acknowledge signal
- Master generates STOP condition followed with START condition or REPEAT START condition
- Master device sends slave address (7-bit) and the data direction bit (R/W = 1).
- Slave device sends acknowledge signal if the slave address is correct.
- Slave sends data byte from addressed register.
- If the master device sends acknowledge signal, the slave device will increase the control register address by one, then send the next data from the new addressed register.
- If the master device generates STOP condition, the read cycle is ended.

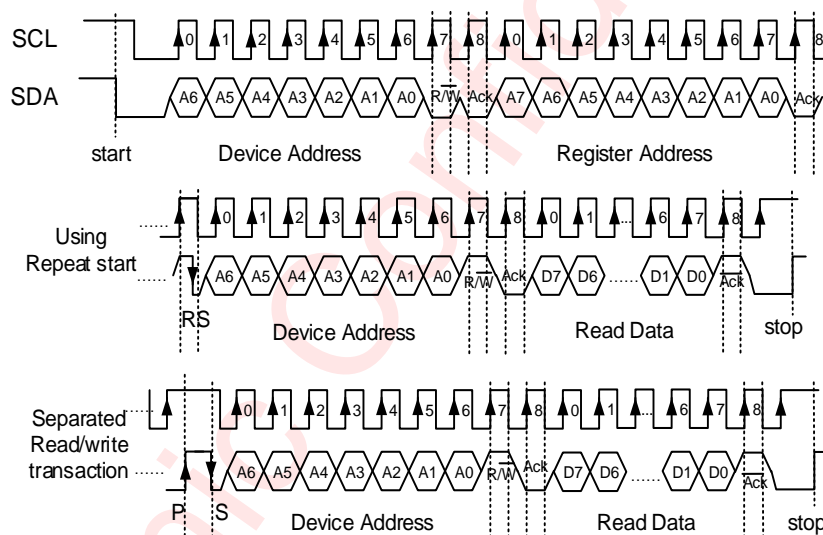


Figure 65 I<sup>2</sup>C Read Byte Cycle



## Register Configuration

### Register MAP

ADDR	NAME	R/W	Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0	Default
0x00	VOUTP	R/W	RSVD[2:0]			VOUTP[4:0]					0x0E
0x01	VOUTN	R/W	RSVD[2:0]			VOUTN[4:0]					0x0E
0x03	APPS	R/W	RSVD	APPS	RESET	ENN	ENP	RSVD	DISP	DISN	0x03
0x04	CTRL	R/W	RSVD[2:0]			ILMTLDO	RSVD		VENDOR[1:0]		0x01
0x21	WPRTEN	R/W	Written protect functional Register								0x00

R/W = Read/Write.

### Register Detailed Description

#### VOUTP : VOUTP Configure Register(Address 00H)

Bit	Symbol	R/W	Description				Default
7:5	RSVD[2:0]	R	Reserved.				0x0E
4:0	VOUTP[4:0]	RW	Output voltage of LDO				
			VOUTP[4:0]	VOUTP(V)	VOUTP[4:0]	VOUTP(V)	
			00000	4.0	01011	5.1	
			00001	4.1	01100	5.2	
			00010	4.2	01101	5.3	
			00011	4.3	01110	<b>5.4(default)</b>	
			00100	4.4	01111	5.5	
			00101	4.5	10000	5.6	
			00110	4.6	10001	5.7	
			00111	4.7	10010	5.8	
			01000	4.8	10011	5.9	
			01001	4.9	10100	6.0	
			01010	5.0			

#### VOUTN : VOUTN Configure Register(Address 01H)

Bit	Symbol	R/W	Description				Default
7:5	RSVD[2:0]	R	Reserved.				0x0E
4:0	VOUTN[4:0]	RW	Output voltage of charge pump				
			VOUTN[4:0]	VOUTN(V)	VOUTN[4:0]	VOUTN(V)	
			00000	-4.0	01011	-5.1	
			00001	-4.1	01100	-5.2	
			00010	-4.2	01101	-5.3	
			00011	-4.3	01110	<b>-5.4(default)</b>	
			00100	-4.4	01111	-5.5	
			00101	-4.5	10000	-5.6	
			00110	-4.6	10001	-5.7	
			00111	-4.7	10010	-5.8	
			01000	-4.8	10011	-5.9	
			01001	-4.9	10100	-6.0	
			01010	-5.0			

**APPS : Applications Configure Register(Address 03H)**

Bit	Symbol	R/W	Description	Default
7	RSVD	R/W	Reserved.	0x03
6	APPS	R/W	Current mode application. <b>0: 80mA mode(default).</b> 1: 150mA mode.	
5	RESET	R/W	Soft reset bit. 0: keep; Write 1: reset.	
4	ENN	R/W	Enable charge pump output. It must be written after writing the register 0x21H=4CH; <b>0: disable (default); 1: enable.</b>	
3	ENP	R/W	Enable LDO output. It must be written after writing the register 0x21H=4CH; <b>0: disable (default); 1: enable.</b>	
2	RSVD	R/W	Reserved.	
1	DISP	R/W	LDO actively discharge enable. 0:disable; <b>1:enable (default).</b>	
0	DISN	R/W	Charge pump actively discharge enable. 0:disable; <b>1:enable (default).</b>	

**CTRL : Control State Configure Register(Address 04H)**

Bit	Symbol	R/W	Description	Default
7:5	RSVD[2:0]	R	Reserved.	0x01
4	ILMTLDO	R/W	LDO output current limit value configure: <b>0: 370mA(default); 1: 270mA.</b>	
3:2	RSVD[1:0]	R	Reserved.	
1:0	VENDOR[1:0]	R	Vendor ID, read only. <b>01: AWINIC Vendor Number(default).</b> 00,10,11: others.	

**WPRTEN : Written Protect Functional Register(Address 21H)**

Bit	Symbol	R/W	Description	Default
7:0	WPRTEN	W/R	Write protect functional register of APPS[4:2]: Write 4CH open written protect function, and read, return 01H; Write other codes to disable writing register of APPS[4:2], and return 00H when read;	0x00

## APPLICATION INFORMATION

The AW37503 employs a single inductor scheme to support positive /negative supply at current up to 150mA. Below are some peripheral selection guidelines.

The first step in the design procedure is to verify whether the maximum possible output current of the boost converter supports the specific application requirement. A simple approach is to estimate the converter efficiency, by taking the efficiency number from the provided efficiency curves at the application's maximum load or to use a worst case assumption for the expected efficiency.

1. Duty cycle:

$$D = 1 - \frac{V_{IN\_min} \times \eta}{V_{REG}} \quad (1)$$

2. Inductor ripple current:

$$\Delta I_L = \frac{V_{IN\_min} \times D}{f_{SW} \times L} \quad (2)$$

3. Maximum output current:

$$I_{OUT\_max} = \left( I_{LIM\_min} + \frac{\Delta I_L}{2} \right) (1 - D) \quad (3)$$

4. Peak switch current of the application:

$$I_{SWPEAK} = \frac{I_{OUT}}{1 - D} + \frac{\Delta I_L}{2} \quad (4)$$

$\eta$  = Estimated boost converter efficiency (use the number from the efficiency plots or 85% as an estimation)

$f_{SW}$  = Boost converter switching frequency

$L$  = Selected inductor value for the boost converter

$I_{SWPEAK}$  = Boost converter switch current at the desired output current (must be <  $[I_{LIM\_min} + \Delta I_L]$ )

$\Delta I_L$  = Inductor peak-to-peak ripple current

$V_{REG} = \max(V_{OUTP}, V_{OUTN}) + 200mV$  (in 80mA mode) or  $+ 400mV$  (in 150mA mode)

$I_{OUT} = I_{OUT\_VOUTP} + |I_{OUT\_VOUTN}|$ , ( $I_{OUT\_max}$  being the maximum current delivered on each rail)

The peak switch current is the current that the integrated switch and the inductor have to handle. The calculation must be done for the minimum input voltage where the peak switch current is highest.

The AW37503 integrates a charge pump to support negative supply. The charge pump uses only two external capacitors C4 and C5 as shown in the figure 1. The output characteristics of this charge pump can be approximated by an ideal voltage source in series with a resistor. The voltage source equals  $-V_{REG}$ . The output resistance  $R_{out}$  is a function of the ON resistance of the internal MOS switches, the oscillator frequency, and the capacitance and ESR of C4 and C5. A good approximation is:

$$R_{OUT} = 2 \times R_{SW} + \frac{1}{F_{OSC} \times C_4} + 4ESR_{C4} + ESR_{C5} \quad (5)$$

Where  $R_{SW}$  is the ON resistance of the internal MOS switches. High value, low ESR capacitors reduce the output resistance. The littler of the distance from C4 to CFLY1/2 in the PCB layout can also reduce the output resistance. Instead of increasing the capacitance, the oscillator frequency can be increased to reduce the  $2/(f_{osc} \times C_4)$  term. Once this term is trivial compared with  $R_{SW}$  and ESRs, further increase to oscillator frequency and capacitance become ineffective. Furthermore larger oscillator frequency can increase quiescent current. The peak to peak output voltage ripple is determined by the oscillator frequency, and the capacitance and ESR of the output capacitor C5:

$$V_{\text{ripple}} = \frac{I_{\text{OUTN}}}{F_{\text{OSC}} \times C_5} + 2 \times I_{\text{OUTN}} \times \text{ESR}_{C5} \quad (6)$$

Again, using a low ESR capacitor results in lower ripple.

The output resistance and ripple voltage are dependent on the capacitance and ESR values of the external capacitors. The output voltage drop from  $V_{\text{RGE}}$  to  $-V_{\text{OUTN}}$  is the load current times the output resistance, and the charge pump efficiency is shown by:

$$\eta = \frac{P_{\text{OUT}}}{P_{\text{IN}}} = \frac{(I_{\text{OUTN}})^2 R_L}{(I_{\text{OUTN}})^2 R_L + (I_{\text{OUTN}})^2 R_{\text{OUT}} + I_{\text{Q(NCP)}}} \quad (7)$$

where

$I_{\text{Q(NCP)}}$  is the quiescent power loss of the charge pump.

$(I_{\text{OUTN}})^2 R_{\text{OUT}}$  is the conversion loss associated with the switch on resistance, the two external capacitors and their ESRs.

## INDUCTOR SELECTION

Saturation current: the inductor must handle the maximum peak current  $\{I_{\text{L\_SAT}} > I_{\text{SWPEAK}}, \text{ or } I_{\text{L\_SAT}} > [I_{\text{LIM\_min}} + \Delta I_{\text{L}}]\}$  as conservation approach}.

DC Resistance: the lower the DCR, the lower the losses. Inductor value: in order to keep the ratio  $I_{\text{OUT}}/\Delta I_{\text{L}}$  low enough for proper sensing operation purpose, it is recommended to use a 4.7 $\mu\text{H}$  inductor for 80mA mode (a 2.2 $\mu\text{H}$  might however be used, but the efficiency might be lower than with 4.7 $\mu\text{H}$  at light loads depending on the inductor characteristics).

L( $\mu\text{H}$ )	Supplier	Component Code	ELA Size	I <sub>SAT</sub> (A)	DCR TYP(m $\Omega$ )
2.2	Toko	1269AS-H-2R2N=P2	1008	2.4	130
2.2	Chilisin	MHCD252012A-2R2M-A8S	2520	2	102
4.7	Toko	1269AS-H-4R7N=P2	1008	1.6	250
4.7	Sunlord	WPN252010HS4R7MT	2520	1.3	276

## CAPACITOR SELECTION

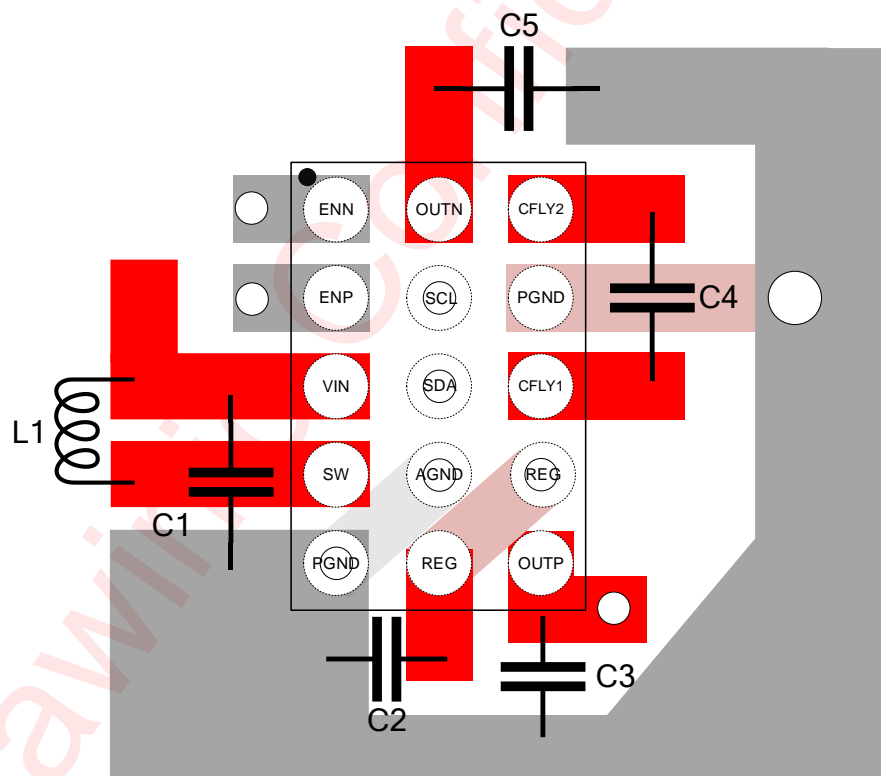
For best input voltage filtering low ESR ceramic capacitors are recommended for input capacitors. The AW37503 has an analog input pin VIN. A 4.7 $\mu\text{F}$  minimum bypass capacitor is required as closed as possible from VIN to GND. For better input voltage filtering, this value can be increased or two capacitors can be used. For output capacitors, higher capacitors values can be used to improve the load transient response and reduce output voltage ripple. For the best output voltage filtering, low ESR ceramic capacitors are recommended. A minimum of 4.7 $\mu\text{F}$  ceramic output capacitors is required. The NCP needs an external flying capacitor. The minimum value is 2.2 $\mu\text{F}$ . For proper operation, the flying capacitor value must be lower than the output capacitor of the boost converter on REG pin.

Capacitor( $\mu\text{F}$ )	Supplier	Component Code	ELA Size	Voltage Rating(V)	Comments
2.2	Murata	GRM188R61C225KAAAD	0603	16	C <sub>FLY</sub>
4.7	Murata	GRM188R61C475KAAJ	0603	16	C <sub>IN</sub> , C <sub>OUTN</sub> , C <sub>FLY</sub> , C <sub>OUTP</sub> , C <sub>REG</sub>
10	Murata	GRM219R61C106KA73	0603	16	C <sub>OUTN</sub> , C <sub>OUTP</sub> , C <sub>REG</sub>

## PCB Layout Consideration

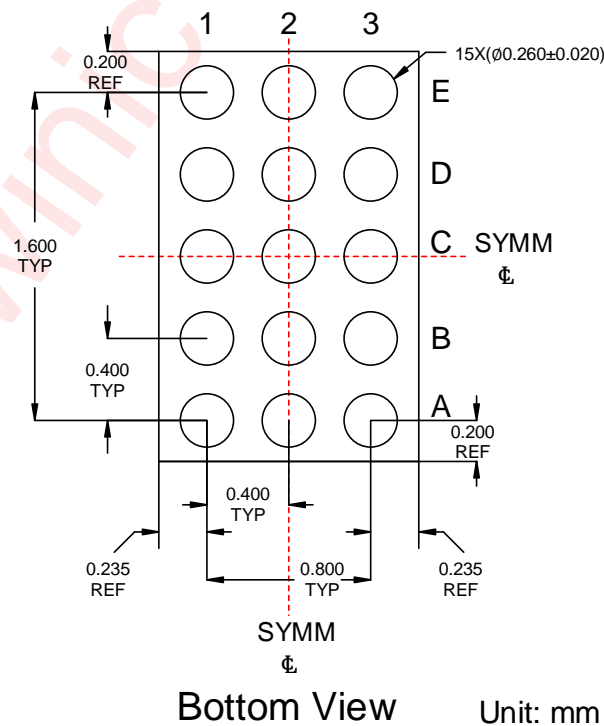
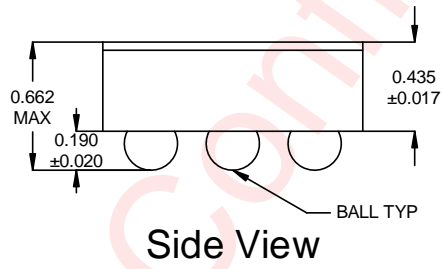
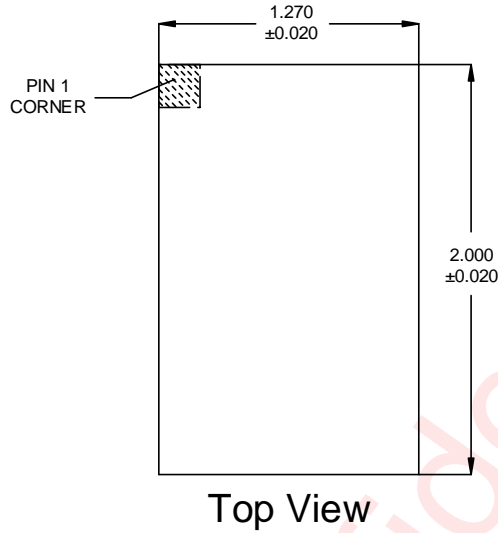
AW37503 is a single inductor and dual outputs power supply, to obtain the optimal performance, PCB layout should be considered carefully. Here are some guidelines:

1. All peripheral components should be placed as close to the chip as possible. C1、C2、C3、C4、C5 and L1 should be close to VIN、REG、OUTP、CFLY1/2 and OUTN pins respectively. Avoid to connect device and chip pins with two different layers of copper, use the same layer of copper instead.
2. VIN and SW are the large current input of the chip, please routed according to 2.5A rule, and the advised width is 100mil.
3. The connection lines between the planes of C1、C2、C3、C4、C5 and respective chip pins should be as short and wide as possible, to reduce noise and ripple.
4. The exposed plane of chip and GND pins must be connected to the large-area ground layer of PCB directly, meanwhile place sufficient via below the exposed plane. Thus we can decrease the thermal resistor on the board to optimize heat-diffusion performance.
5. To achieve optimal large-current performance, the power path shown in red as the figure below must be widened.

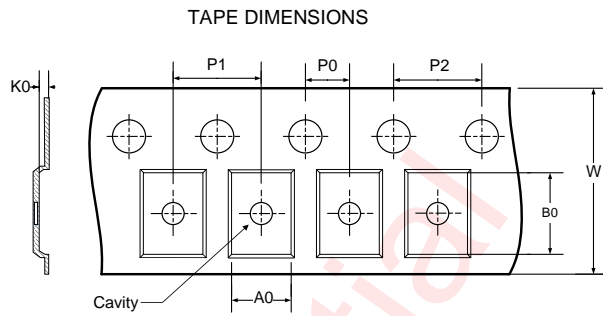
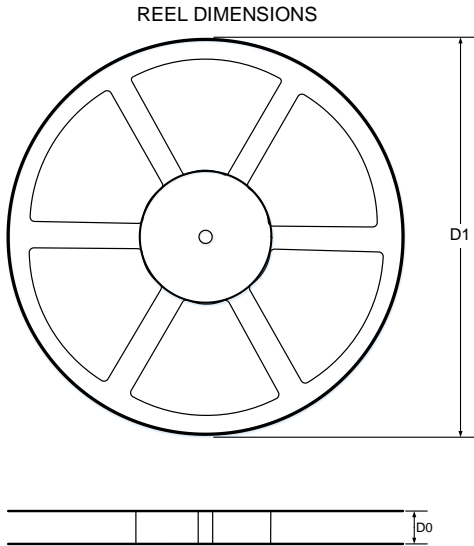


○ Via to signal layer on internal or bottom layer.

Package Description

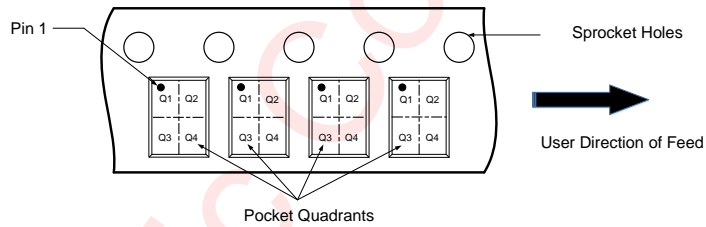


### Tape And Reel Information



- A0: Dimension designed to accommodate the component width
- B0: Dimension designed to accommodate the component length
- K0: Dimension designed to accommodate the component thickness
- W: Overall width of the carrier tape
- P0: Pitch between successive cavity centers and sprocket hole
- P1: Pitch between successive cavity centers
- P2: Pitch between sprocket hole
- D1: Reel Diameter
- D0: Reel Width

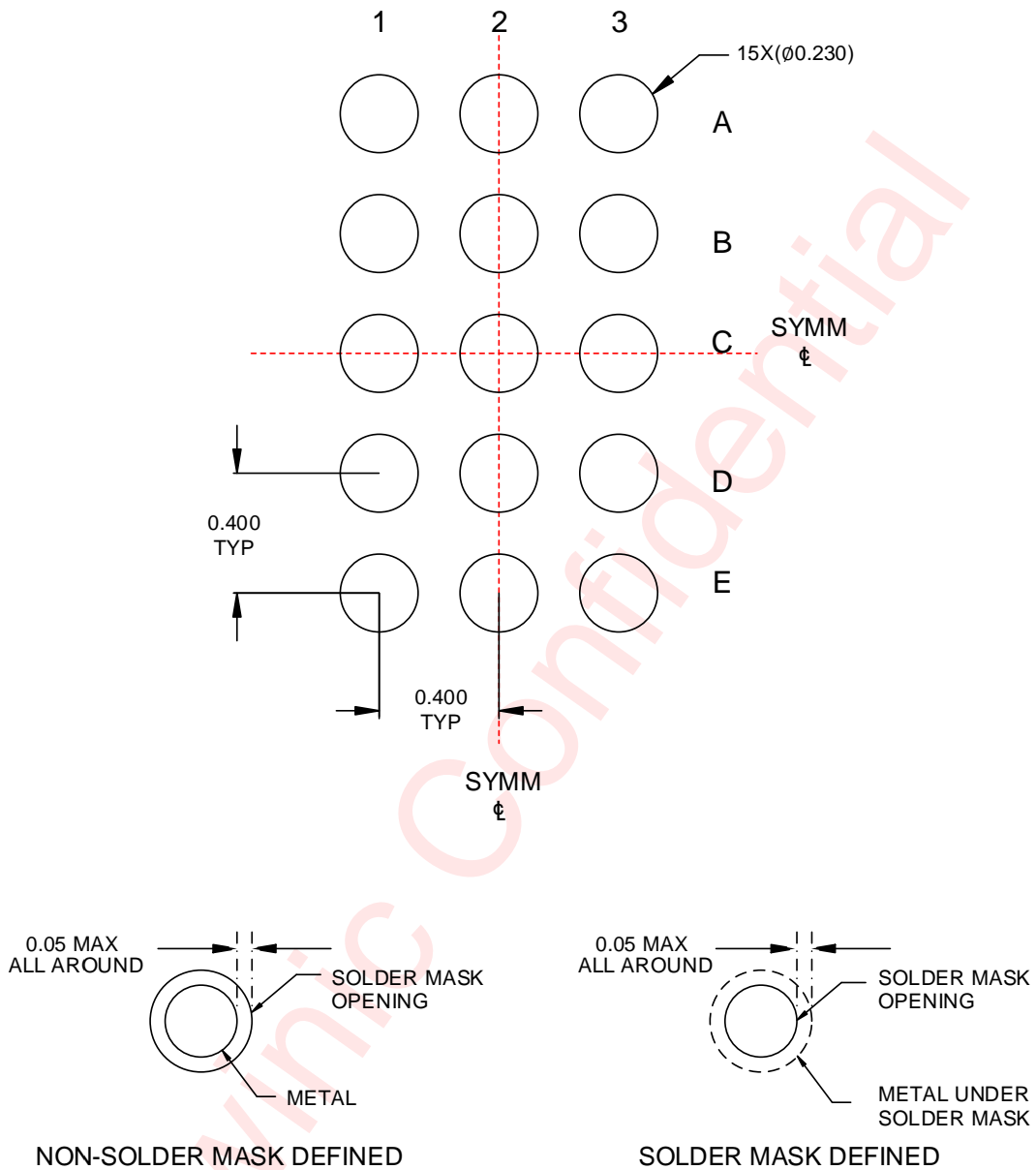
#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



All Dimensions are nominal

D1 (mm)	D0 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P0 (mm)	P1 (mm)	P2 (mm)	W (mm)	Pin1 Quadrant
179.00	9.00	1.40	2.10	0.76	2.00	4.00	4.00	8.00	Q1

Land Pattern Data



UNIT: mm



## Revision History

Version	Date	Change Record
V1.0	Sep. 2020	Official released
V1.1	Apr. 2021	<ol style="list-style-type: none"> <li>1. Changed chip efficiency is greater than 85% condition: amend <math>I_{OUT}&gt;100\text{mA}</math> to <math>I_{OUT}&gt;40\text{mA}</math> (Page 1)</li> <li>2. Changed <math>V_{OUTP}</math> and <math>V_{OUTN}</math> default output condition: amend <math>I_{OUT}=40\text{mA}</math> to <math>I_{OUT}=80\text{mA}</math> (Page 6)</li> <li>3. Added <math>V_{OUTP}</math> line variation and <math>V_{OUTN}</math> line variation to Electrical Characteristics table (Page 6 and Page 7)</li> <li>4. Modified the line regulation of <math>V_{OUTP}</math> and <math>V_{OUTN}</math> (Page 6 and Page 7)</li> <li>5. Revised figure 57 (Page 17)</li> <li>6. Fixed some formatting and syntax errors</li> </ol>
V1.2	Jun. 2021	<ol style="list-style-type: none"> <li>1. Add the range of parameters in Electrical Characteristics (Page 6 and Page 7)</li> <li>2. Add Application Information (Page 27 and Page 28)</li> </ol>
V1.3	Oct. 2021	<ol style="list-style-type: none"> <li>1. Changed the input voltage rang "2.7V to 5.0V" to "2.7V to 5.5V"</li> <li>2. Deleted the ENSTB description in register 0x03[2], and change it to RVDS.</li> <li>3. Added <math>V_{IH}</math>, <math>V_{IL}</math> and <math>V_{OL}</math> parameters of SDA and SCL ports in EC table</li> <li>4. Fixed the molecular numerical error for the second item of formula (5).</li> </ol>
V1.4	Nov. 2021	<ol style="list-style-type: none"> <li>1. Add a recommended application circuit "(b) Suitable for 80mA Mode, and <math>I_{OUT}&lt;40\text{mA}</math>" (Page 4)</li> <li>2. Fixed some formatting errors</li> <li>3. Add a recommended inductor (Page 28)</li> </ol>

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